PCF2131

Nano-Power Highly Accurate RTC with Integrated Quartz Crystal Rev. 2.2 — 20 June 2025

Product data sheet



Document information

Information	Content
Keywords	PCF2131, RTC, accuracy, low power, integrated temperature compensated crystal, I ² C, SPI
Abstract	The PCF2131 is a CMOS Real Time Clock (RTC) and calendar with an integrated Temperature Compensated Crystal (Xtal) Oscillator (TCXO) and a 32.768 kHz quartz crystal optimized for high accuracy and ultra-low power consumption



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1 General description

The PCF2131 is a CMOS Real Time Clock (RTC) and calendar with an integrated Temperature Compensated Crystal (Xtal) Oscillator (TCXO) and a 32.768 kHz quartz crystal optimized for high accuracy and ultra-low power consumption. The PCF2131 has a selectable I²C-bus or SPI-bus, a backup battery switch-over circuit, a programmable watchdog function, four timestamps function, and many other features.

For a selection of NXP RTCs, see <u>Section 15.1</u>.

2 Features and benefits

- Operating temperature ranges from -40 °C to +85 °C
- Temperature Compensated Crystal Oscillator (TCXO) with trimmed integrated capacitors
- Ultra low supply current: typical 64 nA at V_{DD} = 3.3 V
- Temperature compensated RTC, typical accuracy ±3 ppm from -40 °C to +85 °C
- Integration of a 32.768 kHz quartz crystal and oscillator in the same package
- Provides year, month, day, weekday, hours, minutes, seconds, and 1/100 seconds
- · Provides leap year correction
- · Timestamp function
 - with interrupt capability
 - detection of four different events on four input pins (for example, for tamper detection)
- 2-line bidirectional 400 kHz Fast-mode I²C-bus interface
- 4-line SPI-bus with separate data input and output (maximum speed 6.5 Mbit/s)
- · Battery backup input pin and switch-over circuitry
- · Battery backed output voltage
- · Battery low detection function
- Power-on reset (POR)
- · Software reset function
- Two interrupt outputs (open-drain)
- Programmable 1 second or 1 minute interrupt
- · Programmable watchdog timer with interrupt
- · Programmable alarm function with interrupt capability
- · Programmable square output
- Clock operating voltage: 1.2 V to 5.5 V

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3 Applications

- · Electronic metering for electricity, water, and gas
- · Precision timekeeping
- · Access to accurate time of the day
- · GPS equipment to reduce time to first fix
- Applications that require an accurate process timing
- · Products with long automated unattended operation time

4 Ordering information

Table 1. Ordering information

Type number	Topside marking	Package					
		Name	Description	Version			
PCF2131TF	F31	HLSON16	Thermal enhanced low profile small outline; no leads, 16 terminals, 0.125 dimple wettable flank, 0.5 mm pitch, 4.5 mm x 3.5 mm x 1.45 mm body	SOT1992-1			

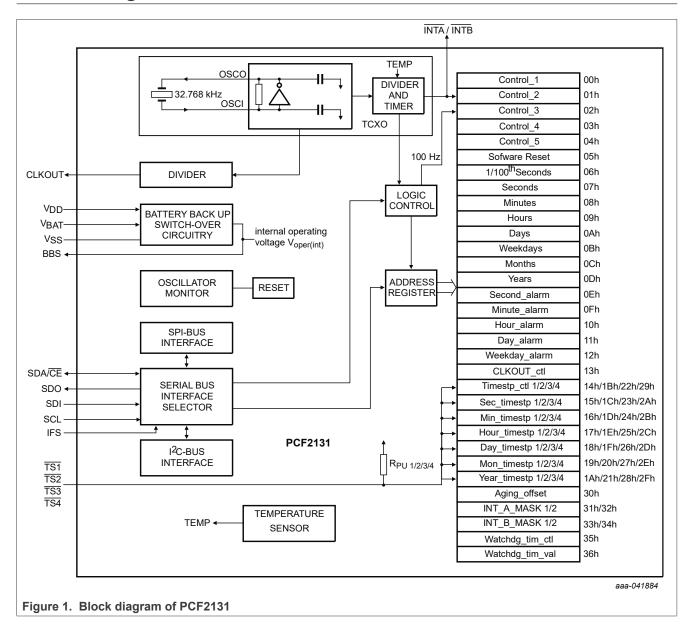
4.1 Ordering options

Table 2. Ordering options

	Orderable part number	Package	3	Minimum Order Quantity	Temperature
PCF2131TF	PCF2131TFY	HLSON16	REEL 13" Q1 DP	4000	T _{amb} = -40 °C to +85 °C

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5 Block diagram

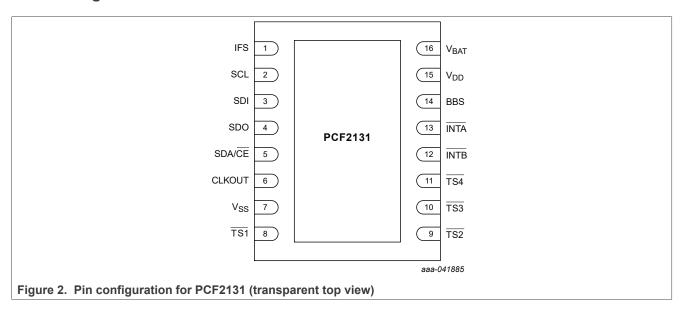


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6 Pinning information

This section outlines the pin configuration and provides a detailed description of the PCF2131.

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Input or input/output pins must always be at a defined level (V_{SS} or V_{DD}) unless otherwise specified.

Symbol	Pin	Description
SCL	2	Combined serial clock input for both I ² C-bus and SPI-bus
SDI	3	Serial data input for SPI-bus Connect to pin V _{SS} if I ² C-bus is selected
SDO	4	Serial data output for SPI-bus, push-pull Leave open or connect to pin V _{SS} if I ² C-bus is selected
SDA/CE	5	Combined serial data input and output for the I ² C-bus and chip enable input (active LOW) for the SPI-bus
IFS	1	Interface selector input Connect to pin V_{SS} to select the SPI-bus Connect to pin V_{DD} to select the I ² C-bus
TS1,TS2,TS3,TS4	8,9,10,11	Timestamp input (active LOW) with 500 k Ω internal pull-up resistor (R _{PU})
CLKOUT	6	Clock output (push-pull)
V _{SS}	7	Ground supply voltage
ĪNTB	12	Interrupt B output (open-drain; active LOW)
ĪNTA	13	Interrupt A output (open-drain; active LOW)
BBS	14	Output voltage (battery backed)

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Table 3. Pin description...continued

Input or input/output pins must always be at a defined level (VSS or VDD) unless otherwise specified.

Symbol	Pin	Description
V_{BAT}	16	Battery supply voltage (backup) Connect to V _{SS} if battery switch-over is not used
V_{DD}	15	Supply voltage
Exposed Pad		Leave floating

7 Functional description

The PCF2131 is an RTC and calendar with an on-chip Temperature Compensated Crystal (Xtal) Oscillator (TCXO) and a 32.768 kHz quartz crystal integrated into the same package.

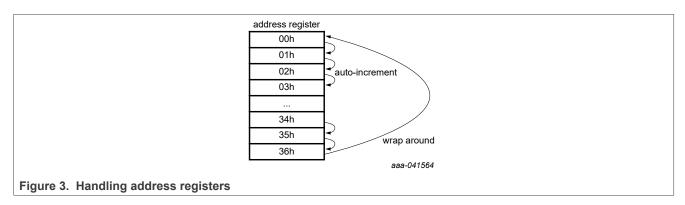
Address and data are transferred by a selectable 400 kHz Fast-mode I²C-bus or a 4-line SPI-bus with separate data input and output (see Section 7.15). The maximum speed of the SPI-bus is 6.5 Mbit/s.

The PCF2131 has a backup battery input pin and backup battery switch-over circuit which monitors the main power supply. The backup battery switch-over circuit automatically switches to the backup battery when a power failure condition is detected (see <u>Section 7.5.1</u>). Accurate timekeeping is maintained even when the main power supply is interrupted.

A battery low detection circuit monitors the status of the battery (see <u>Section 7.5.2</u>). When the battery voltage drops below a certain threshold value, a flag is set to indicate that the battery must be replaced soon. This ensures the integrity of the data during periods of battery backup.

7.1 Register overview

The PCF2131 contains an auto-incrementing address register: the built-in address register increments automatically after each read or write of a data byte up to the register 36h. After register 36h, the auto-incrementing wraps around to address 00h (see Figure 3).



- The first five registers (memory address 00h, 01h, 02h, 03h, and 04h) are used as control registers (see Section 7.2).
- The register at address 05h is for software reset.
- The memory addresses 06h through to 0Dh are used as counters for the clock function (1/100 seconds up to years). The date is automatically adjusted for months with fewer than 31 days, including corrections for leap years. The clock can operate in 12-hour mode with an AM/PM indication or in 24-hour mode (see Section 7.9).
- The registers at addresses 0Eh through 12h define the alarm function. It can be selected that an interrupt is generated when an alarm event occurs (see <u>Section 7.10</u>).

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- The register at address 13h defines the temperature measurement period and the clock out mode. The
 temperature measurement can be selected from every 32 minutes (default) down to every 4 minutes (see
 Table 17). CLKOUT frequencies of 32.768 kHz (default) down to 1 Hz for use as system clock, microcontroller
 clock, and so on, can be chosen (see Table 18).
- The registers at addresses 14h to 2Fh are used for the timestamp function. When the trigger event happens, the actual time is saved in the timestamp registers (see <u>Section 7.12</u>).
- The register at address 30h is used for the correction of the crystal aging effect (see Section 7.4.1).
- The registers at addresses 31h to 34h are used for interrupt configuration.
- The registers at addresses 35h and 36h are used for the watchdog timer functions. The watchdog timer has four selectable source clocks allowing for timer periods from less than 20 ms to greater than 4 hours (see Table 59). An interrupt is generated when the watchdog times out.
- The registers 100th Seconds, Seconds, Minutes, Hours, Days, Months, and Years are all coded in Binary Coded Decimal (BCD) format to simplify application use. Other registers are either bitwise or standard binary.

When one of the RTC registers is written or read, the content of all counters is temporarily frozen, all registers hold their state during SPI or I²C transactions. The time stamp registers would update once the bus transaction completes. This prevents a faulty writing or reading of the clock and calendar during a carry condition (see Section 7.9.9).

Table 4. Register overview

Bit positions labeled as T are unused and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Address	Register name	Bit								Reset value	Reference		
		7	6	5	4	3	2	1	0				
Control re	gisters	<u> </u>					'						
00h	Control_1	EXT_ TEST	TC_DIS	STOP	100TH_ S_DIS	POR_ OVRD	12_24	МІ	SI	0000 1000	Table 5		
01h	Control_2	MSF	WDTF	Т	AF	Т	Т	AIE	Т	0000 0000	Table 7		
02h	Control_3	F	PWRMNG[2:0	0]	BTSE	BF	BLF	BIE	BLIE	1110 0000	Table 9		
03h	Control_4	TSF1	TSF2	TSF3	TSF4	Т	Т	Т	Т	0000 0000	Table 11		
04h	Control_5	TSIE1	TSIE2	TSIE3	TSIE4	Т	Т	Т	Т	0000 0000	Table 13		
Software F	Reset	'		'							'		
05h	SR_Reset	CPR	0	1	0	SR	1	0	CTS	0010 0100	Table 24		
Time and o	date registers			•			•	•			,		
06h	100th_Seconds				100TH_SEC	ONDS(0 to 9	9)			0000 0000	Table 25		
07h	Seconds	OSF			SE	CONDS (0 to	59)			1000 0000	Table 28		
08h	Minutes	-			MI	NUTES (0 to	59)			0000 0000	Table 31		
09h	Hours	AMPM HOURS (1 to 12) in 12-hour mode					0000 0000	Table 33					
					HOURS (0 to 23) in 24-hour mode					0000 0000			
0Ah	Days	-	-			DAYS	(1 to 31)			0000 0001	Table 35		
0Bh	Weekdays	-	-	-	-	-	WE	EKDAYS () to 6)	0000 0001	Table 37		
0Ch	Months	-	-	-		M	ONTHS (1 to	12)		0000 0001	Table 40		
0Dh	Years		_		YEARS	(0 to 99)				0000 0001	Table 43		
Alarm regi	sters												
)Eh	Second_alarm	AE_S		_	SECO	ND_ALARM	(0 to 59)			1000 0000	Table 45		
0Fh	Minute_alarm	AE_M		-	MINU	ΓE_ALARM (0 to 59)			1000 0000	Table 47		
10h	Hour_alarm	AE_H	-	AMPM	Н	OUR_ALAR	M (1 to 12) ii	n 12-hour m	ode	1000 0000	Table 49		
					HOUR_	ALARM (0 to	23) in 24-h	our mode		1000 0000			
11h	Day_alarm	AE_D	-			DAY_ALAI	RM (1 to 31)			1000 0000	Table 51		
12h	Weekday_alarm	AE_W	-	-	-	-	WEEK	DAY_ALAR	M (0 to 6)	1000 0000	Table 53		
CLKOUT c	ontrol register												
13h	CLKOUT_ctl	TCF	R[1:0]	OTPR	-	-		COF[2:0]		00X0 0000	Table 15		
Timestamp	1 registers		<u> </u>	<u> </u>	<u> </u>			<u> </u>					
14h	Timestp_ctl1	TSM	TSOFF	-		SUB	SEC_TIMES	TP[4:0]		0000 0000	Table 64		
15h	Sec_timestp1	-			SECON	D_TIMESTF	(0 to 59)			0000 0000	Table 66		

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Table 4. Register overview...continued

Bit positions labeled as T are unused and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Address	Pogistor name	Bit						- ,		Reset value	Reference
Address	Register name	7	6	5	4	3	2	1	0	- Neset value	Valetelice
16h	Min_timestp1	-	0	3							Table 68
17h	Hour_timestp1	-	_	AMPM	_ , , ,					0000 0000	<u>Table 70</u>
1711	rioui_timestp1	-	_	_					0000 0000	lable 10	
18h	Day timestp1	_	_		11001(_1		STP (1 to 31)			0000 0000	Table 72
19h	1	-	-							0000 0000	
1Ah	Mon_timestp1	-	_	_	VEAD TIME		I_TIMESTP	(11012)			Table 74
	Year_timestp1				TEAK_IIIVIE	STP (0 to 99)			0000 0000	Table 76
	o2 registers	TSM	TSOFF			CLIDO	TIMEST	-D[4.0]		0000 0000	Table 64
1Bh	Timestp_ctl2	13101	130FF	_	SECON		SEC_TIMEST	F[4.0]		0000 0000	Table 64
1Ch	Sec_timestp2	-				D_TIMESTP	. ,			0000 0000	Table 66
1Dh	Min_timestp2	-		444544	1	E_TIMESTP		10.1		0000 0000	Table 68
1Eh	Hour_timestp2	-	-	AMPM				n 12-hour mo	de	0000 0000	<u>Table 70</u>
					HOUR_I	TIMESTP (0 t	-			0000 0000	
1Fh	Day_timestp2	-	-				STP (1 to 31)			0000 0000	Table 72
20h	Mon_timestp2	-	-	-			I_TIMESTP	(1 to 12)		0000 0000	Table 74
21h	Year_timestp2				YEAR_TIME	STP (0 to 99)			0000 0000	Table 76
Timestamp	1				1					T	1
22h	Timestp_ctl3	TSM	TSOFF	-			SEC_TIMEST	P[4:0]		0000 0000	Table 64
23h	Sec_timestp3	-			SECON	D_TIMESTP	(0 to 59)			0000 0000	Table 66
24h	Min_timestp3	-			MINUTE_TIMESTP (0 to 59)					0000 0000	Table 68
25h	Hour_timestp3	-	-	AMPM	НС	DUR_TIMES	ΓP (1 to 12) i	n 12-hour mo	de	0000 0000	Table 70
					HOUR_T	TIMESTP (0 t	o 23) in 24-h	our mode		0000 0000	
26h	Day_timestp3	-	-			DAY_TIMES	STP (1 to 31)			0000 0000	Table 72
27h	Mon_timestp3	-	-	-		MONTH	I_TIMESTP	(1 to 12)		0000 0000	Table 74
28h	Year_timestp3		_		YEAR_TIME	STP (0 to 99)			0000 0000	Table 76
Timestamp	o4 registers										_
29h	Timestp_ctl4	TSM	TSOFF	-		SUBS	EC_TIMEST	P[4:0]		0000 0000	Table 64
2Ah	Sec_timestp4	-			SECON	D_TIMESTP	(0 to 59)			0000 0000	Table 66
2Bh	Min_timestp4	-			MINUTI	E_TIMESTP	(0 to 59)			0000 0000	Table 68
2Ch	Hour_timestp4	-	-	AMPM	НС	OUR_TIMES	ΓP (1 to 12) i	n 12-hour mo	de	0000 0000	Table 70
					HOUR_T	TIMESTP (0 t	o 23) in 24-h	our mode		0000 0000	
2Dh	Day_timestp4	-	-			DAY_TIMES	STP (1 to 31)			0000 0000	Table 72
2Eh	Mon_timestp4	-	-	-		MONTH	_TIMESTP	(1 to 12)		0000 0000	Table 74
2Fh	Year_timestp4		•		YEAR_TIME	STP (0 to 99)			0000 0000	Table 76
Aging offs	et register	'									
30h	Aging_offset	-	-	-	-		AO	[3:0]		0000 1000	Table 19
Interrupt ma	ask registers	-	•			1					
31h	INT_A_MASK1	-	-	MIA	SIA	WD_CDA	AIEA	BIEA	BLIEA	0011 1111	Table 80
3 <u>2</u> h	INT_A_MASK2	-	-	-	-	TSIE1A	TSIE2A	TSIE3A	TSIE4A	0000 1111	Table 80
33h	INT_B_MASK1	-	-	MIB	SIB	WD_CDB	AIEB	BIEB	BLIEB	0011 1111	Table 82
34h	INT_B_MASK2	-	-	-	-	TSIE1B	TSIE2B	TSIE3B	TSIE4B	0000 1111	Table 82
Watchdog	registers		-	1	1	1	1				1
35h	Watchdg_tim_ctl	WD_CD	Т	TI_TP	-	-	-	TF[1:0]	0000 0011	Table 55
36h	Watchdg_tim_val		1		WATCHDG	TIM VAL[7:0	1	1	•	0000 0000	Table 57
		1								1.222.2300	1

7.2 Control registers

The first five registers of the PCF2131, with the addresses 00h, 01h, 02h, 03h, and 04h, are used as control registers.

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7.2.1 Register control_1

Table 5. Control_1 - control and status register 1 (address 00h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	TC_DIS	STOP	100TH_S_ DIS	Т	12_24	MI	SI
Reset value	0	0	0	0	1	0	0	0

Table 6. Control_1 - control and status register 1 (address 00h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description	Reference
7	Т	0	Unused	-
6	TC_DIS	0	Temperature compensation enabled	Section 7.3.1
		1	Temperature compensation disabled	
5	STOP	0	RTC source clock runs	Section 7.14
		1	RTC clock is stopped; RTC divider chain flip-flops are asynchronously set logic 0 CLKOUT output frequencies are still available	
4	100TH_S_DIS	0	100th seconds counter enabled	-
		1	100th seconds counter Disabled, register 06h reset to 00h.	-
3	Т	1	Unused	-
2	12_24	0	24-hour mode selected	Table 34,
		1	12-hour mode selected	Table 50, Table 71
1	MI	0	Minute interrupt disabled	<u>Section 7.13.1</u>
		1	Minute interrupt enabled	
0	SI	0	Second interrupt disabled	1
		1	Second interrupt enabled	

7.2.2 Register control_2

Table 7. Control_2 - control and status register 2 (address 01h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	MSF	WDTF	Т	AF	Т	Т	AIE	Т
Reset value	0	0	0	0	0	0	0	0

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Table 8. Control_2 - control and status register 2 (address 01h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description	Reference
7	MSF	0	No minute or second interrupt generated	Section 7.13
		1	Flag set when minute or second interrupt generated; Flag must be cleared to clear interrupt	
6	WDTF	0	No watchdog timer interrupt generated	<u>Section 7.13.3</u>
		1	Flag set when watchdog timer interrupt generated; Flag must be cleared to clear interrupt	_
5	Т	0	Unused	-
4	AF	0	No alarm interrupts were triggered	<u>Section 7.10.6</u>
		1	Flag set when alarm triggered; Flag must be cleared to clear interrupt	_
3:2	Т	0	Unused	-
1	AIE	0	No interrupt generated from the alarm flag	<u>Section 7.13.4</u>
		1	Interrupt generated when alarm flag set	
0	Т	0	Unused	-

7.2.3 Register control_3

Table 9. Control_3 - control and status register 3 (address 02h) bit allocation

Bit	7	6	5	4	3	2	1	0
Symbol	PWRMNG[2:0]			BTSE	BF	BLF	BIE	BLIE
Reset value	1 1 1			0	0	0	0	0

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Table 10. Control_3 - control and status register 3 (address 02h) bit description

Bit	Symbol	Value	Description	Reference
7 to 5	PWRMNG[2:0]	See Table 22	Control of the battery switch-over, battery low detection, and extra power fail detection functions	Section 7.5
4	BTSE	0	No timestamp when battery switch-over occurs	<u>Section 7.12.4</u>
		1	Time-stamped when battery switch-over occurs	
3	BF	0	No battery switch-over interrupt occurred	Section 7.5.1
	1		Flag set when battery switch-over occurs; Flag must be cleared to clear interrupt	and Section 7.12.4
2	BLF	0	Battery status ok; No battery low interrupt generated	Section 7.5.2
		1	Battery status low flag cannot be cleared by command, the flag is automatically cleared when battery is replaced.	
1	BIE	0	No interrupt generated from the Battery Flag (BF)	<u>Section 7.13.6</u>
		1	Interrupt generated when BF is set	
0	BLIE	0	No interrupt generated from Battery Low Flag (BLF)	<u>Section 7.13.7</u>
		1	Interrupt generated when BLF is set	

7.2.4 Register control_4

Table 11. Control_4 - control and status register 4 (address 03h) bit allocation

Bit	7	6	5	4	3	2	1	0
Symbol	TSF1	TSF2	TSF3	TSF4	Т	Т	Т	Т
Reset value	0	0	0	0	0	0	0	0

Table 12. Control_4 - control and status register 4 (address 03h) bit description

Bit	Symbol	Value	Description	Reference
7	TSF1	0	No timestamp interrupt generated for pin TS1	<u>Section 7.12.1</u>
		1	Flag set when TS1 input is driven to ground: Flag must be cleared to clear interrupt	
6	TSF2	0	No timestamp interrupt generated when pin TS2	<u>Section 7.12.1</u>
		1	Flag set when TS2 input is driven to ground; Flag must be cleared to clear interrupt	
5	TSF3	0	No timestamp interrupt generated for pin TS3	<u>Section 7.12.1</u>
		1	Flag set when TS3 input is driven to ground; Flag must be cleared to clear interrupt	
4	TSF4	0	No timestamp interrupt generated when pin $\overline{\overline{1S4}}$	<u>Section 7.12.1</u>
		1	flag set when TS4 input is driven to ground; Flag must be cleared to clear interrupt	

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Table 12. Control_4 - control and status register 4 (address 03h) bit description...continued

Bit	Symbol	Value	Description	Reference
3	Т	0	Unused	-
2	Т	0	Unused	-
1	Т	0	Unused	-
0	Т	0	Unused	-

7.2.5 Register control_5

Table 13. Control_5 - control and status register 5 (address 04h) bit allocation

Bit	7	6	5	4	3	2	1	0
Symbol	TSIE1	TSIE2	TSIE3	TSIE4	Т	Т	Т	Т
Reset value	0	0	0	0	0	0	0	0

Table 14. Control_5 - control and status register 5 (address 04h) bit description

Bit	Symbol	Value	Description	Reference
7	TSIE1	0	No interrupt generated from timestamp flag of TS1	<u>Section 7.13.5</u>
		1	Interrupt generated when timestamp flag set of TS1	
6	TSIE2	0	No interrupt generated from timestamp flag of TS2	<u>Section 7.13.5</u>
		1	Interrupt generated when timestamp flag set of TS2	
5	TSIE3	0	No interrupt generated from timestamp flag of TS3	<u>Section 7.13.5</u>
		1	Interrupt generated when timestamp flag set of TS3	
4	TSIE4	0	No interrupt generated from timestamp flag of TS4	<u>Section 7.13.5</u>
		1	Interrupt generated when timestamp flag set of TS4	_
3 to 0	Т	0	Unused	-

7.3 Register CLKOUT_ctl

Table 15. CLKOUT_ctl - CLKOUT control register (address 13h) bit allocation

Bits labeled as T are unused and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0
Symbol	TCR[1:0]		OTPR	Т	Т	COF[2:0]		
Reset value	0	0	X	0	0	0	0	0

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Table 16. CLKOUT_ctl - CLKOUT control register (address 13h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description	Reference
7 to 6	TCR[1:0]	See <u>Table 17</u>	See <u>Table 17</u> Temperature measurement period	
5	OTPR	0	No OTP refresh	Section 7.3.2
		1	OTP refresh performed	
4	Т	0	Unused ^[1]	
3	Т	0	Unused	
2 to 0	COF[2:0]	See <u>Table 18</u>	CLKOUT frequency selection	Section 7.3.3

^[1] Programming this bit to 1 may lead to a decrease of timing accuracy.

7.3.1 Temperature compensated RTC

The frequency of tuning fork quartz crystal oscillators is temperature-dependent. In the PCF2131, the frequency deviation caused by temperature variation is corrected by adjusting the RTC frequency divider with digital method.

The load capacitance is trimmed to the required value at 25 °C to compensate the frequency deviation over process variation.

The frequency accuracy at 25 °C can be evaluated by measuring the frequency of the square wave signal available at the output pin CLKOUT. However, the selection of $f_{CLKOUT} = 32.768$ kHz (default value) can lead to inaccurate measurements. Accurate frequency measurement occurs when $f_{CLKOUT} = 16.384$ kHz or lower is selected (see Table 18).

The temperature compensated frequency input for the RTC cannot be observed at the CLKOUT pin but can be evaluated by following these steps.

- Set the Second Interrupt and also set bit SI in register Control 1 to 1.
- Set bit TI TP in register Watchdg tim ctl to 1 for a pulsed interrupt signal.
- Set bit SIA in register INTA MASK 1 to 0 to direct the Second Interrupt to pin INTA for a 1 Hz pulse output.

The RTC temperature compensation works by adding or deleting pulses at the 32.768 kHz level. These correction pulses are spaced evenly over a sufficiently long period of time to reach the required resolution and accuracy. Every second corrections with a resolution of about 30.5 ppm (1/32768) can be generated by the temperature compensation engine. If for instance a 10 ppm correction is called for, the correction pulses will be generated approximately once every 3 seconds, for a 50 ppm correction every 0.6 s and so on.

The 1 Hz interrupt output signal can be measured with a counter and by selecting an appropriate gating time the measurement resolution can be set to the desired level. A gating time of 100 s for instance determines the averaged 1 second period with a resolution of 0.3 ppm.

The feature of temperature compensation can be turned off for ultra low power consumption by first performing a software reset (SR) followed by setting TC DIS to '1' within 5 seconds.

7.3.1.1 Temperature measurement

The PCF2131 has a temperature sensor circuit used to perform temperature compensation of the clock input to the RTC. The temperature is measured immediately after power-on and then periodically with a period set by the temperature conversion rate TCR[1:0] in the register CLKOUT_ctl. During the first approximately 60 s after startup, the compensation will be inactive, after this period the temperature compensation is active.

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Table 17. Temperature measurement period

TCR[1:0]	Note	Temperature measurement period
00	[1]	32 min
01		16 min
10		8 min
11		4 min

^[1] Default value.

7.3.2 OTP refresh

Each IC is calibrated during production and testing of the device. The calibration parameters are stored on EPROM cells called One Time Programmable (OTP) cells. It is recommended to process an OTP refresh once after the power is up and the oscillator is operating stable. The OTP refresh takes less than 100 ms to complete.

To perform an OTP refresh, bit OTPR has to be cleared (set to logic 0) and then set to logic 1 again.

When read OTPR bit, its state is:

"0" until the OTP read state machine completes copying of the eFuse data into the shadow registers. This could be due to a POR event or to writing a 0 > 1 to the OTPR register bit.

"1" when the OTP read state machine completes copying to the shadow registers from the eFuse instances. During normal operation OTPR must be kept at 1 to prevent higher power usage.

The OTP logic is not affected by the Software Reset. The OTPR functionality is only reset by the initial digital POR.

During OTP refresh, V_{DD} must be above 1.8 V. The rising speed from 0 V to 1.8 V needs to be faster than 2 V/100 ms. After OTP refresh has finished, PCF2131 can operate with V_{DD} as low as 1.2 V.

7.3.3 Clock output

A programmable square wave is available at pin CLKOUT. Operation is controlled by the COF[2:0] control bits in register CLKOUT_ctl. Frequencies of 32.768 kHz (default) down to 1 Hz can be generated for use as system clock, microcontroller clock, charge pump input, or for calibrating the oscillator at 25 °C to determine aging offset. The CLKOUT output is not temperature compensated to prevent jitter due to the digital compensation method.

CLKOUT is a push-pull output and is enabled at power-on. When disabled, the output is high-impedance.

Table 18. CLKOUT frequency selection

COF[2:0]	Note	CLKOUT frequency (Hz)	Typical duty cycle ^[1]
000	[2]	32 768	60 : 40 to 40 : 60
001		16 384	50 : 50
010		8 192	50 : 50
011		4 096	50 : 50
100		2 048	50 : 50
101		1 024	50 : 50
110		1	50 : 50
111		CLKOUT = high-Z	-

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- [1] Duty cycle definition: % HIGH-level time: % LOW-level time.
- [2] Default value.

The duty cycle of the selected clock is not controlled, however, due to the nature of the clock generation all but the 32.768 kHz frequencies are 50 : 50.

7.4 Register Aging offset

Table 19. Aging_offset - crystal aging offset register (address 30h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	Т	Т	AO[3:0]			
Reset value	0	0	0	0	1	0	0	0

Table 20. Aging_offset - crystal aging offset register (address 30h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
7 to 4	Т	0000	Unused
3 to 0	AO[3:0]	See <u>Table 21</u>	Aging offset value

7.4.1 Crystal aging correction

The PCF2131 has an offset register Aging_offset to correct the crystal aging effects. 1

The accuracy of the frequency of a quartz crystal depends on its aging. The aging offset adds an adjustment, positive or negative, in the temperature compensation circuit which allows correcting the aging effect.

The aging offset bits allow a frequency correction of typically 2 ppm per AO[3:0] value, from -14 ppm to +16 ppm.

Table 21. Frequency correction at 25 °C, typical

AO[3:0]	ppm		
Decimal	Binary	Note	
0	0000		+16
1	0001		+14
2	0010		+12
3	0011		+10
4	0100		+8
5	0101		+6
6	0110		+4
7	0111		+2
8	1000	[1]	0
9	1001		-2

¹ For further information, refer to the application note $\underline{\text{ref.}[1]}$.

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Table 21. Frequency correction at 25 °C, typical...continued

AO[3:0]	ppm		
Decimal	Binary	Note	
10	1010		-4
11	1011		-6
12	1100		-8
13	1101		-10
14	1110		-12
15	1111		-14

^[1] Default value.

7.5 Power management functions

The PCF2131 has two power supplies:

V_{DD} - the main power supply

V_{BAT} - the battery backup supply

Internally, PCF2131 operates with the internal operating voltage $V_{oper(int)}$ which is also available as V_{BBS} on the battery backed output voltage pin, BBS. Depending on the condition of the main power supply and the selected power management function, $V_{oper(int)}$ is either on the potential of V_{DD} or V_{BAT} .

Two power management functions are implemented:

Battery switch-over function - monitors the main power supply V_{DD} and switching to V_{BAT} in case a power fail condition is detected (see Section 7.5.1).

Battery low detection function - monitors the status of the battery, V_{BAT} (see Section 7.5.2).

The power management functions are controlled by the control bits PWRMNG[2:0] (see <u>Table 22</u>) in register Control_3 (see <u>Table 10</u>):

Table 22. Power management control bit description

PWRMNG[2:0]	Note	Function
000		Battery switch-over function is enabled in standard mode; Battery low detection function is enabled
001,010		Battery switch-over function is enabled in standard mode; Battery low detection function is disabled
011		Battery switch-over function is enabled in direct switching mode; Battery low detection function is enabled
100,101		Battery switch-over function is enabled in direct switching mode; Battery low detection function is disabled
110,111	[1] [2]	Battery switch-over function is disabled, only one power supply (V_{DD}) ; Battery low detection function is disabled

^[1] Default value

When the battery switch-over function is disabled, the device works only with the power supply V_{DD}. V_{BAT} must be put to ground and the battery low detection function is disabled.

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7.5.1 Battery switch-over function

PCF2131 has a backup battery switch-over circuit which monitors the main power supply V_{DD} . When a power failure condition is detected, it automatically switches to the backup battery.

One of two operation modes can be selected:

Standard mode - the power failure condition happens when:

$$V_{DD} < V_{BAT}$$
 AND $V_{DD} < V_{th(sw)bat}$

 $V_{th(sw)bat}$ is the battery switch threshold voltage. The typical value is 2.5 V. The battery switch-over in standard mode works only for $V_{DD} > 2.5$ V. Applying back-up battery voltage to V_{BAT} without applying V_{DD} supply will not power on the device; only when V_{DD} main power is supplied the device starts operating.

Direct switching mode - the power failure condition happens when $V_{DD} < V_{BAT}$. Direct switching from V_{DD} to V_{BAT} without requiring V_{DD} to drop below $V_{th(sw)bat}$.

When a power failure condition occurs and the power supply switches to the battery, the following sequence occurs:

- 1. The battery switch flag BF (register Control 3) is set to logic 1.
- 2. An interrupt is generated if the control bit BIE (register Control 3) is enabled (see Section 7.13.6).
- 3. If the control bit BTSE (register Control_3) is logic 1, the timestamp 4 registers store the time and date when the battery switch occurred (see Section 7.12.4).
- 4. The battery switch flag BF is cleared by command; it must be cleared to clear the interrupt.

The interface and CLKOUT output are disabled in battery backup operation:

- Interface inputs are not recognized, preventing extraneous data being written to the device.
- · Interface outputs are high-impedance.

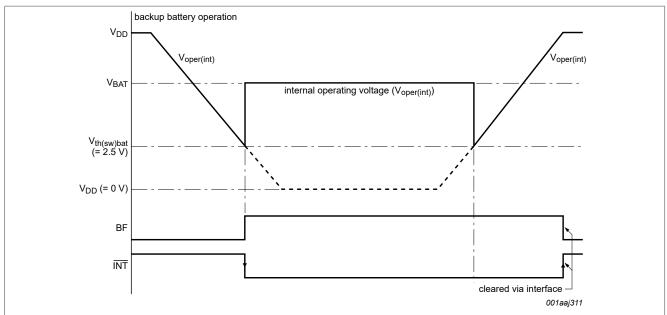
For further information about I²C-bus communication and battery backup operation, see Section 7.15.3.

7.5.1.1 Standard mode

If $V_{DD} > V_{BAT}$ OR $V_{DD} > V_{th(sw)bat}$: $V_{oper(int)}$ is at V_{DD} potential.

If $V_{DD} < V_{BAT}$ AND $V_{DD} < V_{th(sw)bat}$: $V_{oper(int)}$ is at V_{BAT} potential.

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 $V_{th(sw)bat}$ is the battery switch threshold voltage. The typical value is 2.5 V. In standard mode, the battery switch-over works only for $V_{DD} > 2.5$ V.

 V_{DD} may be lower than V_{BAT} (for example V_{DD} = 3 V, V_{BAT} = 4.1 V).

Figure 4. Battery switch-over behavior in standard mode with bit BIE set logic 1 (enabled)

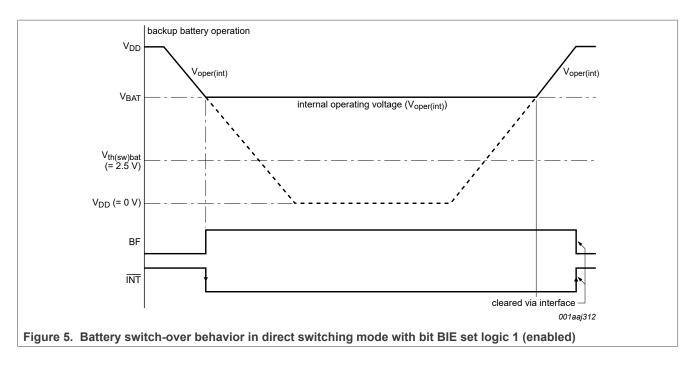
7.5.1.2 Direct switching mode

If $V_{DD} > V_{BAT}$: $V_{oper(int)}$ is at V_{DD} potential.

If $V_{DD} < V_{BAT}$: $V_{oper(int)}$ is at V_{BAT} potential.

The direct switching mode is useful in systems where V_{DD} is always higher than V_{BAT} . This mode is not recommended if the V_{DD} and V_{BAT} values are similar (for example, V_{DD} = 3.3 V, V_{BAT} \geq 3.0 V). In direct switching mode, the power consumption is reduced compared to the standard mode because the monitoring of V_{DD} and $V_{th(sw)bat}$ is not performed.

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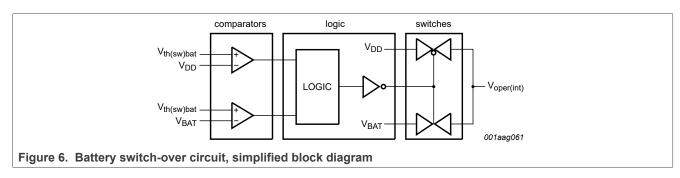
7.5.1.3 Battery switch-over disabled: only one power supply (V_{DD})

When the battery switch-over function is disabled:

- The power supply is applied on the V_{DD} pin
- The V_{BAT} pin must be connected to ground
- V_{oper(int)} is at V_{DD} potential
- The battery flag (BF) is always logic 0

7.5.1.4 Battery switch-over architecture

The architecture of the battery switch-over circuit is shown in Figure 6.



 $V_{oper(int)}$ is at V_{DD} or V_{BAT} potential.

Remark: It has to be assured that there are decoupling capacitors on the pins V_{DD}, V_{BAT}, and BBS.

7.5.2 Battery low detection function

The PCF2131 has a battery low detection circuit which monitors the status of the battery V_{BAT}.

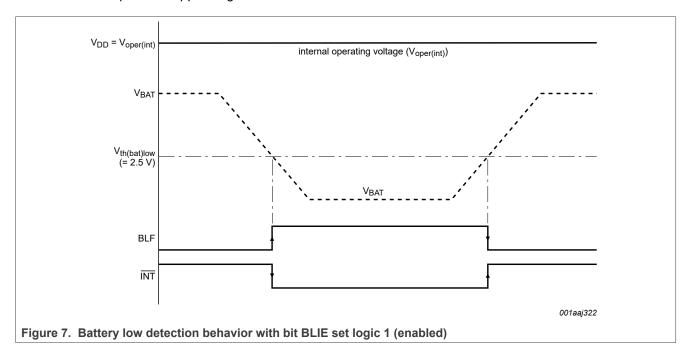
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When V_{BAT} drops below the threshold value $V_{th(bat)low}$ (typical 2.5 V), the BLF flag (register Control_3) is set to indicate that the battery is low and that it must be replaced. Monitoring of the battery voltage also occurs during battery operation.

An unreliable battery cannot prevent the supply voltage from dropping below V_{low} (typical 1.2 V) and with that the data integrity gets lost. (For further information about V_{low} see <u>Section 7.6</u>.)

When V_{BAT} drops below the threshold value $V_{th(bat)low}$, the following sequence occurs (see <u>Figure 7</u>):

- 1. The battery low flag BLF is set to logic 1.
- 2. An interrupt is generated if the control bit BLIE (register Control 3) is enabled (see Section 7.13.7).
- 3. The flag BLF remains logic 1 until the battery is replaced. BLF cannot be cleared by command. It is automatically cleared by the battery low detection circuit when the battery is replaced or when the voltage rises again above the threshold value. This could happen if a super capacitor is used as a backup source and the main power is applied again.



7.5.3 Battery backup supply

The V_{BBS} voltage on the output pin BBS is at the same potential as the internal operating voltage $V_{oper(int)}$, depending on the selected battery switch-over function mode:

Table 23. Output pin BBS

Battery switch-over function mode	Conditions	Potential of V _{oper(int)} and V _{BBS}
Standard	$V_{DD} > V_{BAT} OR V_{DD} > V_{th(sw)bat}$	V_{DD}
	$V_{DD} < V_{BAT}$ AND $V_{DD} < V_{th(sw)bat}$	V_{BAT}
Direct switching	$V_{DD} > V_{BAT}$	V_{DD}
	$V_{DD} < V_{BAT}$	V _{BAT}
Disabled	only V _{DD} available, V _{BAT} must be put to ground	V _{DD}

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The output pin BBS can be used as a supply for external devices with battery backup needs, such as SRAM (see <u>ref.[1]</u>).

7.6 Oscillator stop detection function

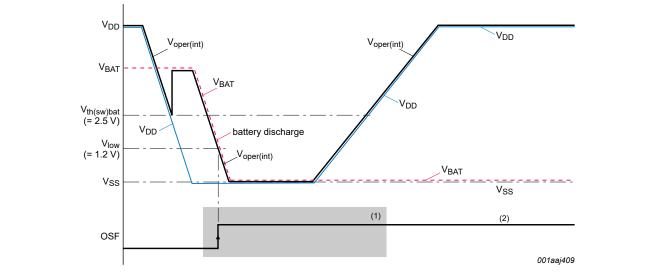
The PCF2131 has an on-chip oscillator detection circuit which indicates the status of the oscillation by monitoring the supply of oscillator: whenever the supply is out of the expected range, a reset occurs and the Oscillator Stop Flag (OSF, in register Seconds) is set logic 1.

Power-on:

- 1. The oscillator is not running and the chip is in reset (OSF is logic 1).
- 2. When the oscillator starts running and the supply is OK after power-on, the chip exits from reset.
- 3. The flag OSF is still logic 1 and can be cleared (OSF set logic 0) by command.

• Power supply failure:

- 1. When the power supply of the chip drops below a certain value (V_{low}) , typically 1.2 V, the oscillator supply also fails and a reset occurs.
- 2. When the power supply returns to normal operation, the oscillator supply is OK again, the chip exits from reset
- 3. The flag OSF is still logic 1 and can be cleared (OSF set logic 0) by command.
- 4. When OSF flag is cleared, an OTP refresh should be performed (see Section 7.3.2).



- 1. Theoretical state of the signals since there is no power.
- 2. The Oscillator Stop Flag (OSF), set logic 1, indicates that the oscillation has stopped and a reset has occurred since the flag was last cleared (OSF set logic 0). In this case, the integrity of the clock information is not guaranteed. The OSF flag is cleared by command.

Figure 8. Power failure event due to battery discharge: reset occurs

7.7 Power-On Reset function

The PCF2131 has a Power-On Reset (POR) function implemented.

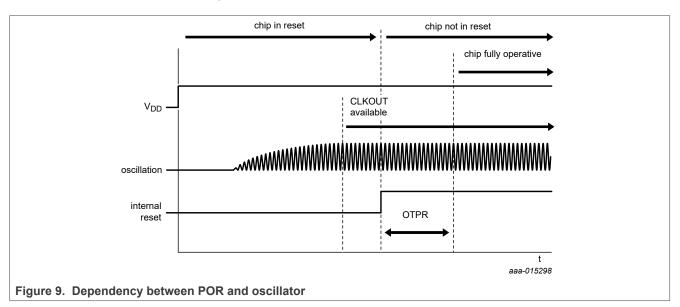
7.7.1 Power-On Reset (POR)

The POR is active whenever the oscillator is stopped. The oscillator is considered to be stopped during the time between power-on and stable crystal resonance (see <u>Figure 9</u>). This time may be in the range of 200 ms to 2 s

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depending on temperature and supply voltage. Whenever an internal reset occurs, the oscillator stop flag is set (OSF set logic 1).

The OTP refresh (see <u>Section 7.3.2</u>) should ideally be executed as the first instruction after startup and also after a reset due to an oscillator stop.



After POR, the following mode is entered:

- 32.768 kHz CLKOUT active
- · 24-hour mode is selected
- Battery switch-over function disabled, only one power supply (V_{DD})
- · Temperature compensation enabled
- · 100th second enabled
- Time 00:00:00.00
- Date 2001.01.01
- · Weekday Monday

The register values after power-on are shown in Table 4.

7.8 Software reset register

Table 24. Reset - software reset control (address 05h) bit description

Bit	7	6	5	4	3	2	1	0
Symbol	CPR	0	1	0	SR	1	0	CTS
Section	Section 7.8.2				Section 7.8.1			Section 7.8.3

То

- Trigger a software reset (SR), 0010 1100 (2Ch) must be sent to register Reset (address 05h). A software reset also triggers CPR and CTS.
- Clear prescaler (CPR), 1010 0100 (A4h) must be sent to register Reset (address 05h).
- Clear timestamp (CTS), 0010 0101 (25h) must be sent to register Reset (address 05h).

It is possible to combine CPR and CTS by sending 1010 0101 (A5h).

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Read of the SR_RESET register returns a fixed pattern of 00100100;

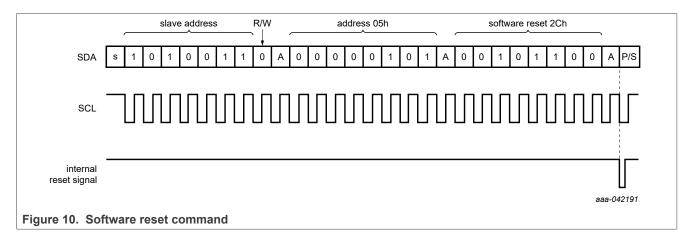
Remark: Any other value sent to this register is ignored.

7.8.1 SR: software reset

A reset is automatically generated at power-on as Power-On Reset as described in <u>Section 7.7</u>. A reset can also be initiated with the software reset command.

After software reset, the following mode is entered:

- · 32.768 kHz CLKOUT active
- OTP not reloaded, OTPR unchanged
- · 24-hour mode is selected
- Battery switch-over function disabled, only one power supply (V_{DD})
- Temperature compensation enabled
- · 100th second enabled
- Time 00:00:00.00
- Date 2001.01.01
- · Weekday Monday



7.8.2 CPR: clear prescaler

To set the time for RTC mode, the clear prescaler instruction is needed.

Before sending this instruction, it is mandatory to first set stop by the STOP bit.

See the STOP definition for an explanation on using this instruction.

7.8.3 CTS: clear timestamp

The timestamp registers (address 14h to 2Fh) can be set to all 0 with this instruction.

7.9 Time and date function

Most of these registers are coded in the Binary Coded Decimal (BCD) format.

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7.9.1 Register 100th Seconds

Table 25. 100th Seconds - 100th seconds (address 06h) bit allocation

Bit	7	6	5	4	3	2	1	0		
Symbol	100TH SECO	00TH SECONDS (0 to 99)								
Reset value	0	0	0	0	0	0	0	0		

Table 26. 100th Seconds - 100th seconds register (address 06h) bit description

Bit	Symbol	Value	Place value	Description
7 to 4	100TH SECONDS	0 to 9	Ten's place	Actual seconds coded in BCD format
3 to 0		0 to 9	Unit place	

Table 27. 100th Seconds coded in BCD format

Seconds	Upper-digi	t (ten's place)			Digit (unit place)			
value in decimal	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
00	0	0	0	0	0	0	0	0
01	0	0	0	0	0	0	0	1
02	0	0	0	0	0	0	1	0
:	:	:	:	:	:	:	:	:
09	0	0	0	0	1	0	0	1
10	0	0	0	1	0	0	0	0
:	:	:	:	:	:	:	:	:
98	1	0	0	1	1	0	0	0
99	1	0	0	1	1	0	0	1

7.9.2 Register Seconds

Table 28. Seconds - seconds and clock integrity register (address 07h) bit allocation

Bit	7	6	5 4 3 2 1 0 ECONDS (0 to 59)							
Symbol	OSF	SECONDS (0								
Reset value	1	0	0	0	0	0	0	0		

Table 29. Seconds - seconds and clock integrity register (address 07h) bit description

Bit	Symbol	Value	Place value	Description
7	OSF	0	-	Clock integrity is guaranteed
		1	-	Clock integrity is not guaranteed: The oscillator has stopped and chip reset has occurred since the flag was last cleared

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Table 29. Seconds - seconds and clock integrity register (address 07h) bit description...continued

Bit	Symbol	Value	Place value	Description
6 to 4	SECONDS	0 to 5	Ten's place	Actual seconds coded in BCD format
3 to 0		0 to 9	Unit place	

Table 30. Seconds coded in BCD format

Seconds	Upper-dig	git (ten's place))	Digit (uni	Digit (unit place)				
value in decimal	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0		
00	0	0	0	0	0	0	0		
01	0	0	0	0	0	0	1		
02	0	0	0	0	0	1	0		
:	:	:	:	:	:	:	:		
09	0	0	0	1	0	0	1		
10	0	0	1	0	0	0	0		
:	:	:	:	:	:	:	:		
58	1	0	1	1	0	0	0		
59	1	0	1	1	0	0	1		

7.9.3 Register Minutes

Table 31. Minutes - minutes register (address 08h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	MINUTES (0	INUTES (0 to 59)					
Reset value	0	0	0	0	0	0	0	0

Table 32. Minutes - minutes register (address 08h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
7	Т	0	-	Unused
6 to 4	MINUTES	0 to 5	Ten's place	Actual minutes coded in BCD format
3 to 0		0 to 9	Unit place	

7.9.4 Register Hours

Table 33. Hours - hours register (address 09h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	AMPM	HOURS (1 to	12) in 12-hou	ır mode		

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Table 33. Hours - hours register (address 09h) bit allocation...continued Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
			HOURS (0 0to 23) in 24-hour mode					
Reset value	0	0	0	0	0	0	0	0

Table 34. Hours - hours register (address 09h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description		
7 to 6	Т	00	-	Unused		
12-hour mode ^[1]						
5	AMPM	0	-	Indicates AM		
		1	-	Indicates PM		
4	HOURS	0 to 1	Ten's place	Actual hours coded in BCD format when in 12-hour		
3 to 0		0 to 9	Unit place	mode		
24-hour mod	de ^[1]					
5 to 4	HOURS	0 to 2	Ten's place	Actual hours coded in BCD format when in 24-hour		
3 to 0		0 to 9	Unit place	mode		

^[1] Hour mode is set by the bit 12_24 in register Control_1 (see <u>Table 6</u>).

7.9.5 Register Days

Table 35. Days - days register (address 0Ah) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	DAYS (1 to 31)					
Reset value	0	0	0	0	0	0	0	0

Table 36. Days - days register (address 0Ah) bit description

Bit	Symbol	Value	Place value	Description
7 to 6	Т	00	-	Unused
5 to 4	DAYS ^[1]	0 to 3	Ten's place	Actual day coded in BCD format
3 to 0		0 to 9	Unit place	

^[1] If the year counter contains a value which is exactly divisible by 4, excluding the year 00, the RTC compensates for leap years by adding a 29th day to February. Note that the next time the year will roll over to 00 will be the year 2100, which is not going to be a leap year.

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7.9.6 Register Weekdays

Table 37. Weekdays - weekdays register (address 0Bh) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	Т	Т	Т	WEEKDAYS	(0 to 6)	
Reset value	0	0	0	0	0	0	0	1

Table 38. Weekdays - weekdays register (address 0Bh) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
7 to 3	Т	000	Unused
2 to 0	WEEKDAYS	0 to 6	Actual weekday value, see <u>Table 39</u>

Although the association of the weekdays counter to the actual weekday is arbitrary, the PCF2131 assumes that Sunday is 000 and Monday is 001 for the purpose of determining the increment for calendar weeks.

Table 39. Weekday assignments

Day ^[1]	Bit		
	2	1	0
Sunday	0	0	0
Monday	0	0	1
Tuesday	0	1	0
Wednesday	0	1	1
Thursday	1	0	0
Friday	1	0	1
Saturday	1	1	0

^[1] The definition may be reassigned by the user.

7.9.7 Register Months

Table 40. Months - months register (address 0Ch) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	Т	MONTHS (1	to 12)			
Reset value	0	0	0	0	0	0	0	1

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Table 41. Months - months register (address 0Ch) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
7 to 5	Т	000	-	Unused
4	MONTHS	0 to 1	Ten's place	Actual month coded in BCD format, see Table 42
3 to 0		0 to 9	Unit place	

Table 42. Month assignments in BCD format

Month	Upper-digit (ten's place)	Digit (unit place)						
	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0			
January	0	0	0	0	1			
February	0	0	0	1	0			
March	0	0	0	1	1			
April	0	0	1	0	0			
May	0	0	1	0	1			
June	0	0	1	1	0			
July	0	0	1	1	1			
August	0	1	0	0	0			
September	0	1	0	0	1			
October	1	0	0	0	0			
November	1	0	0	0	1			
December	1	0	0	1	0			

7.9.8 Register Years

Table 43. Years - years register (address 0Dh) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	YEARS (0 to	99)						
Reset value	0	0	0	0	0	0	0	1

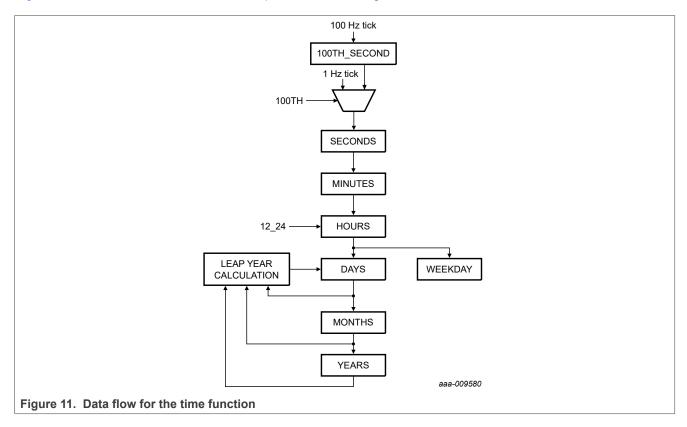
Table 44. Years - years register (address 0Dh) bit description Bits labeled as T are unused and return 0 when read.

BitSymbolValuePlace valueDescription7 to 4YEARS0 to 9Ten's placeActual year coded in BCD format3 to 00 to 9Unit place

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7.9.9 Setting and reading the time

Figure 11 shows the data flow and data dependencies starting from the 100 Hz/1 Hz clock tick.



Write access requires setting the STOP bit. The flow for accurately setting the time in RTC mode is:

- Start an I2C access at register control 1
- Set the STOP bit
- Set CPR (register SR RESET, CPR is logic 1)
- · Address counter rolls over to address 06h
- Set time (100th seconds, seconds to years)
- End I2C access
- · Wait for an external time reference to indicate that time counting should start
- · Start an I2C access at register control 1
- · Clear STOP bit (time starts counting from now)
- End I2C access

The first increment of the time circuits is between 0 s and 122 ms after STOP is released. See description for STOP bit in Section 7.14.

During read operations, the time counting circuits (memory locations 06h through 0Dh) are blocked. This prevents the following:

- Faulty reading of the clock and calendar during a carry condition
- Incrementing the time registers during the read cycle

After this read access is completed, the time circuit is released again. Any pending request to increment the time counters that occurred during the read access is serviced.

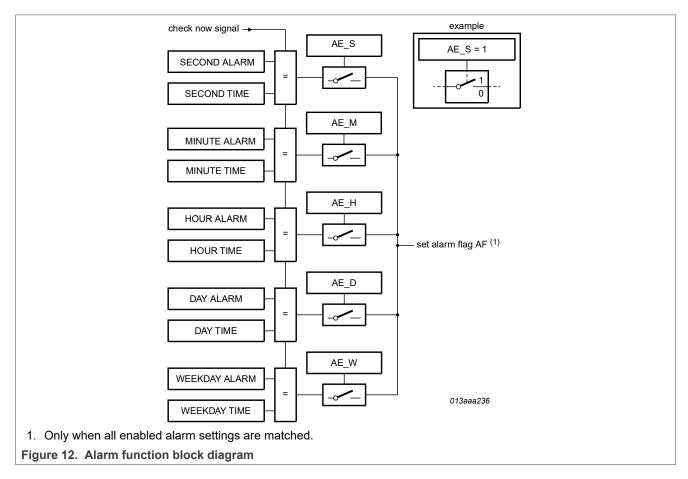
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As a consequence of this method, it is important to make a read access in one go. That is, reading seconds through to years should be made in one single access. Failing to comply with this method could result in the time becoming corrupted.

As an example, a roll-over may occur between reads, thus giving the minutes from one moment and the hours from the next. Therefore, it is advised to read all time and date registers in one access.

7.10 Alarm function

When one or more of the alarm bit fields are loaded with a valid second, minute, hour, day, or weekday and its corresponding alarm enable bit (AE_x) is logic 0, then that information is compared with the actual second, minute, hour, day, and weekday (see Figure 12).



The generation of interrupts from the alarm function is described in <u>Section 7.13.4</u>.

7.10.1 Register Second_alarm

Table 45. Second_alarm - second alarm register (address 0Eh) bit allocation Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0	
Symbol	AE_S	SECOND_AL	COND_ALARM (0 to 59)						
Reset value	1	0	0	0	0	0	0	0	

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Table 46. Second_alarm - second alarm register (address 0Eh) bit description

Bit	Symbol	Value	Place value	Description
7	AE_S	0	-	Second alarm is enabled
		1	-	Second alarm is disabled
6 to 4	SECOND_ALARM	0 to 5	Ten's place	Second alarm information coded in BCD format
3 to 0		0 to 9	Unit place	

7.10.2 Register Minute_alarm

Table 47. Minute_alarm - minute alarm register (address 0Fh) bit allocation

Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0	
Symbol	AE_M	MINUTE_AL	NUTE_ALARM (0 to 59)						
Reset value	1	0	0	0	0	0	0	0	

Table 48. Minute_alarm - minute alarm register (address 0Fh) bit description Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Place value	Description
7	AE_M	0	-	Minute alarm is enabled
		1	-	Minute alarm is disabled
6 to 4	MINUTE_ALARM	0 to 5	Ten's place	Minute alarm information coded in BCD format
3 to 0		0 to 9	Unit place	

7.10.3 Register Hour_alarm

Table 49. Hour_alarm - hour alarm register (address 10h) bit allocation ${\bf r}$

Bits labeled as T are unused and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0	
Symbol	AE_H	Т	AMPM HOUR_ALARM (1 to 12) in 12-hour mode HOUR_ALARM (0 to 23) in 24-hour mode						
Reset value	1	0	0	0	0	0	0	0	

Table 50. Hour_alarm - hour alarm register (address 10h) bit description

Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Place value	Description
7	AE_H	0	-	Hour alarm is enabled
		1	-	Hour alarm is disabled

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Table 50. Hour_alarm - hour alarm register (address 10h) bit description...continued

Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Place value	Description
6	Т	0	-	Unused
12-hour mod	le ^[1]			
5	AMPM	0	-	Indicates AM
			-	Indicates PM
4	HOUR_ALARM	0 to 1	Ten's place	Hour alarm information coded in BCD format when in
3 to 0		0 to 9	Unit place	12-hour mode
24-hour mod	le ^[1]			
5 to 4	HOUR_ALARM	0 to 2	Ten's place	Hour alarm information coded in BCD format when in
3 to 0		0 to 9	Unit place	24-hour mode

^[1] Hour mode is set by the bit 12_24 in register Control_1.

7.10.4 Register Day_alarm

Table 51. Day_alarm - day alarm register (address 11h) bit allocation

Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0	
Symbol	AE_D	Т	DAY_ALARM	DAY_ALARM (1 to 31)					
Reset value	1	0	0	0	0	0	0	0	

Table 52. Day_alarm - day alarm register (address 11h) bit description

Bits labeled as T are unused and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by

Bit	Symbol	Value	Place value	Description
7	AE_D	0	-	Day alarm is enabled
		1	-	Day alarm is disabled
6	Т	0	-	Unused
5 to 4	DAY_ALARM	0 to 3	Ten's place	Day alarm information coded in BCD format
3 to 0		0 to 9	Unit place	

subsequent resets.

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7.10.5 Register Weekday_alarm

Table 53. Weekday_alarm - weekday alarm register (address 12h) bit allocation

Bits labeled as T are unused and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0
Symbol	AE_W	Т	Т	Т	Т	WEEKDAY_ALARM (0 to 6)		
Reset value	1	0	0	0	0	0	0	0

Table 54. Weekday_alarm - weekday alarm register (address 12h) bit description

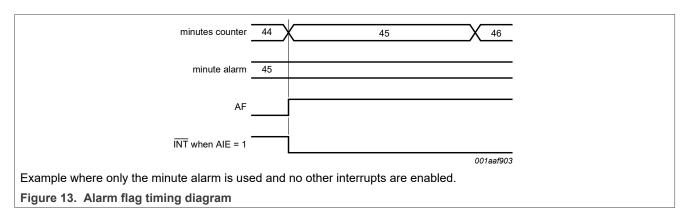
Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Description
7	AE_W	0	Weekday alarm is enabled
		1	Weekday alarm is disabled
6 to 3	Т	0	Unused
2 to 0	WEEKDAY_ALARM	0 to 6	Weekday alarm information

7.10.6 Alarm Flag (AF)

When all enabled comparisons match for the first time, the AF (register Control_2) is set. AF remains set until cleared by command. Once AF is cleared, it is set again only when the time increments to match the alarm condition once more. For clearing the flags, see <u>Section 7.11.5</u>.

Alarm registers which have their alarm enable bit AE x at logic 1 are ignored.



7.11 Watchdog timer functions

The PCF2131 has a watchdog timer function. The timer can be switched on and off by using the control bit WD_CD in the register Watchdg_tim_ctl.

The watchdog timer has four selectable source clocks. It can, for example, be used to detect a micro-controller with interrupt and reset capability which is out of control (see <u>Section 7.11.3</u>).

To control the timer function and timer output, the registers Control_2, Watchdg_tim_ctl, and Watchdg_tim_val are used.

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7.11.1 Register Watchdg_tim_ctl

Table 55. Watchdg_tim_ctl - watchdog timer control register (address 35h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	WD_CD	Т	TI_TP	Т	Т	Т	TF[1:0]	
Reset value	0	0	0	0	0	0	1	1

Table 56. Watchdg_tim_ctl - watchdog timer control register (address 35h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
7	WD_CD	0	Watchdog timer interrupt disabled
		1	Watchdog timer interrupt enabled; The interrupt pin INTA/B is activated when timed out
6	Т	0	Unused
5	TI_TP	0	The interrupt pin INTA/B is configured to generate a permanent active signal when MSF is set
		1	The interrupt pin INTA/B is configured to generate a pulsed signal when MSF flag is set (see Figure 15)
4 to 2	Т	000	Unused
1 to 0	TF[1:0]		Timer source clock for watchdog timer
		00	64 Hz
		01	4 Hz
		10	1/ ₄ Hz
		11	1/ ₆₄ Hz

7.11.2 Register Watchdg_tim_val

Table 57. Watchdg_tim_val - watchdog timer value register (address 36h) bit allocation

Bit	7	6	5	4	3	2	1	0		
Symbol	WATCHDG_	VATCHDG_TIM_VAL[7:0]								
Reset value	0	0	0	0	0	0	0	0		

Table 58. Watchdg_tim_val - watchdog timer value register (address 36h) bit description Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Description
7 to 0	WATCHDG_TIM_ VAL[7:0]	00 to FF	Timer period in seconds: $TimerPeriod = \frac{(n-1)+/-0.5}{SourceClockFrequency}$

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Table 58. Watchdg_tim_val - watchdog timer value register (address 36h) bit description Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Description
			Where n is the timer value (n > 1)
			Write Only

Table 59. Programmable watchdog timer

TF[1:0]	Timer source clock frequency	Units	Minimum timer period (n = 2)	Units	Maximum timer period (n = 255)	Units
00	64	Hz	15.625	ms	3.984	s
01	4	Hz	250	ms	63.744	s
10	1/4	Hz	4	s	1020	s
11	1/64	Hz	64	s	16320	s

7.11.3 Watchdog timer function

The watchdog timer interrupt function is enabled or disabled by the WD_CD bit of the register Watchdg_tim_ctl (see <u>Table 56</u>).

The 2 bits TF[1:0] in register Watchdg_tim_ctl determine one of the four source clock frequencies for the watchdog timer: 64 Hz, 4 Hz, $\frac{1}{4}$ Hz or $\frac{1}{64}$ Hz (see <u>Table 59</u>).

When the watchdog timer function is enabled, the 8-bit timer in register Watchdg_tim_val determines the watchdog timer period (see <u>Table 59</u>).

The watchdog timer counts down from the software programmed 8-bit binary value n in register Watchdg_tim_val. When the counter reaches 1, the watchdog timer flag WDTF (register Control_2) is set logic 1 and an interrupt is generated. The period accuracy corresponds to n +/- 0.5.

The register Watchdg tim val is write only and not readable after set.

The counter does not automatically reload.

When WD_CD is logic 1/0 (watchdog timer interrupt enabled/disabled) and the Micro-controller Unit (MCU) loads a watchdog timer value n:

- The flag WDTF is reset
- INTA/B is cleared
- · The watchdog timer starts again

Loading the counter with 0 or 1 will:

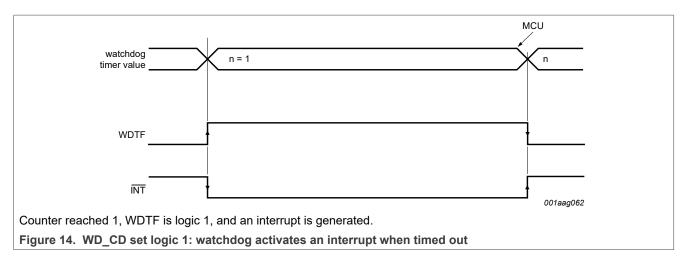
- · Reset the flag WDTF
- Clear INTA/B
- · Stop the watchdog timer

Remark: WDTF can be cleared by:

- Loading a value in register Watchdg_tim_val
- · Writing a logic 0 to WDTF

Writing a logic 1 to WDTF has no effect.

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- When the watchdog timer counter reaches 1, the watchdog timer flag WDTF is set logic 1.
- When a minute or second interrupt occurs, the minute/second flag MSF is set logic 1 (see Section 7.13.1).

7.11.4 Predefined timers: second and minute interrupts

PCF2131 has two predefined timers which are used to generate an interrupt either once per second or once per minute (see <u>Section 7.13.1</u>). The pulse generator for the minute or second interrupt operates from an internal 64 Hz clock. It is independent of the watchdog timer. Each of these timers can be enabled by the bits SI (Second Interrupt) and MI (Minute Interrupt) in register Control 1.

7.11.5 Clearing flags

The flags MSF and AF can be cleared by command. To prevent one flag being overwritten while clearing another, a logic AND is performed during the write access. A flag is cleared by writing logic 0 while a flag is not cleared by writing logic 1. Writing logic 1 results in the flag value remaining unchanged.

Two examples are given for clearing the flags. Clearing a flag is made by a write command:

- Bits labeled with must be written with their previous values
- Bits labeled with T have to be written with logic 0
- WDTF is read only and has to be written with logic 0

Repeatedly rewriting these bits has no influence on the functional behavior.

Table 60. Flag location in register Control 2

Register	Bit								
	7	6	5	4	3	2	1	0	
Control_2	MSF	WDTF	Т	AF	Т	-	-	T	

Table 61. Example values in register Control_2

Register	Bit	Bit								
	7	6	5	4	3	2	1	0		
Control_2	1	0	1	1	0	0	0	0		

The following tables show what instruction must be sent to clear the appropriate flag.

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Table 62. Example to clear only AF (bit 4)

Register	Bit	t							
	7	6	5	4	3	2	1	0	
Control_2	1	0	1	0	0	0 ^[1]	0 ^[1]	0	

^[1] The bits labeled as - have to be rewritten with the previous values.

Table 63. Example to clear only MSF (bit 7)

Register	Bit	t							
	7	6	5	4	3	2	1	0	
Control_2	0	0	1	1	0	0 ^[1]	0 ^[1]	0	

^[1] The bits labeled as - have to be rewritten with the previous values.

7.12 Timestamp function

The PCF2131 has four active LOW timestamp input pins $\overline{TS1}$, $\overline{TS2}$, $\overline{TS3}$, and $\overline{TS4}$, internally pulled with on-chip pull-up resistors to $V_{oper(int)}$. It also has a timestamp detection circuit which can detect the event when inputs on pin $\overline{TS1/2/3/4}$ are driven to ground.

The timestamp function is enabled by default after power-on and it can be switched off by setting the control bit TSOFF (register Timestp_ctl1/2/3/4).

The time recorded in the time stamps, when in 100 Hz disable mode (1 Hz mode), is at least two 16 Hz clocks behind the timestamp event and no more than 3 clocks behind. If the exact time of the timestamp event is required then subtract 2 subseconds from the timestamp value and the result will have -0 subseconds to +1 subseconds of uncertainty.

A most common application of the timestamp function is described in ref.[1].

See Section 7.13.5 for a description of interrupt generation from the timestamp function.

7.12.1 Timestamp flag

When the $\overline{TS1/2/3/4}$ input pin is driven to ground, the following sequence occurs:

- 1. The actual date and time are stored in the timestamp registers.
- 2. The timestamp flag TSF1/2/3/4 is set.
- 3. If the TSIE1/2/3/4 bit is active, and the corresponding interrupt mask is disabled, an interrupt on the INTA/B pin is generated.

The TSF1/2/3/4 and TSF1/2/3/4_2 flags can be cleared by command; clearing the flag clears the interrupt. Once TSF1/2/3/4 is cleared, it will only be set again when $\overline{TS1/2/3/4}$ pin is driven to ground once again.

7.12.2 Timestamp mode

The timestamp function has two different modes selected by the control bit TSM (timestamp mode) in register Timestp ctl:

- If TSM is logic 0 (default): in subsequent trigger events without clearing the timestamp flags, the last timestamp event is stored
- If TSM is logic 1: in subsequent trigger events without clearing the timestamp flags, the first timestamp event is stored

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The timestamp function also depends on the control bit BTSE in register Control_3, see Section 7.12.4.

7.12.3 Timestamp registers

This section covers the bit allocation and its description for various timestamp registers.

7.12.3.1 Register Timestp_ctl1/2/3/4

Table 64. Timestp_ctl1/2/3/4 - timestamp control register (address 14h/1Bh/22h/29h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	TSM	TSOFF	Т	SUBSEC_TIMESTP[4:0]				
Reset value	0	0	0	0	0	0	0	0

Table 65. Timestp_ctl1/2/3/4 - timestamp control register (address 14h/1Bh/22h/29h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
7	TSM	0	In subsequent events without clearing the timestamp flags, the last event is stored
		1	In subsequent events without clearing the timestamp flags, the first event is stored
6	TSOFF	0	Timestamp function active
		1	Timestamp function disabled
5	-	-	Unused
4 to 0	SUBSEC_TIMESTP[4:0]		$^{1}/_{16}$ second timestamp information coded in BCD format when 100TH_S_DIS = '1'[^{1}], $^{1}/_{20}$ second timestamp information coded in BCD format when 100TH_S_DIS = '0';

^[1] The time recorded in the time stamps, when in 100 Hz disable mode (1 Hz mode), will be at least two 16 Hz clocks behind the timestamp event and no more than 3 clocks behind. If the exact time of the timestamp event is required then subtract 2 subseconds from the timestamp value and the result will have -0 subseconds to +1 subseconds of uncertainty.

7.12.3.2 Register Sec_timestp

Table 66. Sec_timestp1/2/3/4 - second timestamp register (address 15h/1Ch/23h/2Ah) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	SECOND_TII	COND_TIMESTP (0 to 59)					
Reset value	0	0	0	0	0	0	0	0

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Table 67. Sec_timestp1/2/3/4 - second timestamp register (address 15h/1Ch/23h/2Ah) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
7	Т	0	-	Unused
6 to 4	SECOND_TIMESTP	0 to 5	ten's place	Second timestamp information coded in BCD format
3 to 0		0 to 9	unit place	

7.12.3.3 Register Min_timestp

Table 68. Min_timestp1/2/3/4 - minute timestamp register (address 16h/1Dh/24h/2Bh) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	MINUTE_TIM	IUTE_TIMESTP (0 to 59)					
Reset value	0	0	0	0	0	0	0	0

Table 69. Min_timestp1/2/3/4 - minute timestamp register (address 16h/1Dh/24h/2Bh) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
7	Т	0	-	Unused
6 to 4	MINUTE_TIMESTP	0 to 5	Ten's place	Minute timestamp information coded in BCD format
3 to 0		0 to 9	Unit place	

7.12.3.4 Register Hour_timestp

Table 70. Hour_timestp1/2/3/4 - hour timestamp register (address 17h/1Eh/25h/2Ch) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0	
Symbol	Т	Т	AMPM HOUR_TIMESTP (1 to 12) in 12-hour mode						
			HOUR_TIMESTP (0 to 23) in 24-hour mode						
Reset value	0	0	0	0	0	0	0	0	

Table 71. Hour_timestp1/2/3/4 - hour timestamp register (address 17h/1Eh/25h/2Ch) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description					
7 to 6	-	-	-	Unused					
12-hour mode ^[1]									
5	AMPM	0	-	Indicates AM					
		1	-	Indicates PM					

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Table 71. Hour_timestp1/2/3/4 - hour timestamp register (address 17h/1Eh/25h/2Ch) bit description...continued Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description						
4	HOUR_TIMESTP	0 to 1	Ten's place	Hour timestamp information coded in BCD format						
3 to 0		0 to 9	Unit place	when in 12-hour mode						
24-hour mod	24-hour mode ^[1]									
5 to 4	HOUR_TIMESTP	0 to 2	Ten's place	Hour timestamp information coded in BCD format						
3 to 0		0 to 9	Unit place	when in 24-hour mode						

^[1] Hour mode is set by the bit 12_24 in register Control_1.

7.12.3.5 Register Day_timestp

Table 72. Day_timestp1/2/3/4 - day timestamp register (address 18h/1Fh/26h/2Dh) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	DAY_TIMES	DAY_TIMESTP (1 to 31)				
Reset value	0	0	0	0	0	0	0	0

Table 73. Day_timestp1/2/3/4 - day timestamp register (address 18h/1Fh/26h/2Dh) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
7 to 6	Т	00	-	Unused
5 to 4	DAY_TIMESTP	0 to 3	Ten's place	Day timestamp information coded in BCD format
3 to 0		0 to 9	Unit place	

7.12.3.6 Register Mon_timestp

Table 74. Mon_timestp1/2/3/4 - month timestamp register (address 19h/20h/27h/2Eh) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	Т	Т	Т	MONTH_TIMESTP (1 to 12)				
Reset value	0	0	0	0	0 0 0			

Table 75. Mon_timestp1/2/3/4 - month timestamp register (address 19h/20h/27h/2Eh) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
7 to 5	Т	000	-	Unused
4	MONTH_TIMESTP	0 to 1	Ten's place	Month timestamp information coded in BCD format

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Table 75. Mon_timestp1/2/3/4 - month timestamp register (address 19h/20h/27h/2Eh) bit description...continued Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Place value	Description
3 to 0		0 to 9	Unit place	

7.12.3.7 Register Year_timestp

Table 76. Year timestp1/2/3/4 - year timestamp register (address 1Ah/21h/28h/2Fh) bit allocation

Bit	7	6	5	4	3	2	1	0			
Symbol	YEAR_TIME	/EAR_TIMESTP (0 to 99)									
Reset value	0	0	0	0	0	0	0	1			

Table 77. Year timestp1/2/3/4 - year timestamp register (address 1Ah/21h/28h/2Fh) bit description

Bit	Symbol	Value	Place value	Description
7 to 4	YEAR_TIMESTP	0 to 9	Ten's place	Year timestamp information coded in BCD format
3 to 0		0 to 9	Unit place	

7.12.4 Dependency between Battery switch-over and timestamp

The timestamp function depends on the control bit BTSE in register Control_3:

Table 78. Battery switch-over and timestamp

BTSE	BF	Note	Description
0	-	[1]	The battery switch-over does not affect the timestamp registers
1			If a battery switch-over event occurs:
	0	[2]	The timestamp 4 group registers store the time and date when the switch-over occurs; after this event occurred BF is set logic 1
	1		The timestamp 4 group registers are not modified; in this condition subsequent battery switch-over events or falling edges on pin TS4 are not registered

^[1] Default value

7.13 Interrupt output, INTA/INTB

PCF2131 has two interrupt output pins INTA and INTB which are open-drain, active LOW (requiring a pull-up resistor if used). Interrupts may be sourced from different places:

- Second or minute timer
- · Watchdog timer
- Alarm
- Timestamp1/2/3/4
- Battery switch-over

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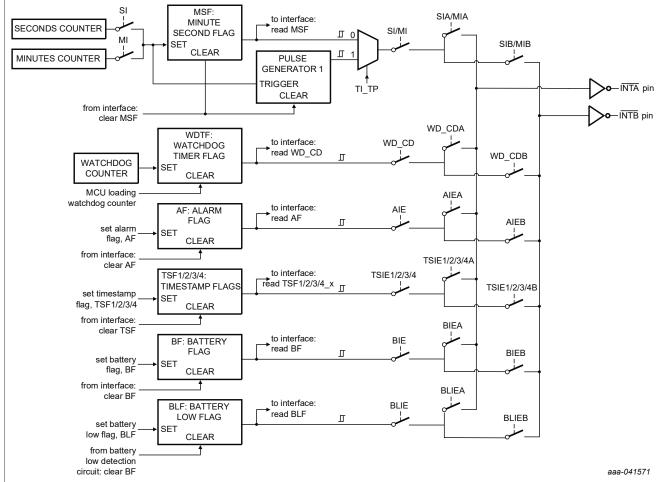
^[2] Default value.

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· Battery low detection

The control bit TI_TP (register Watchdg_tim_ctl) is used to configure whether the interrupts generated from the second/minute timer (flag MSF in register Control_2) are pulsed signals or a permanently active signal. All the other interrupt sources generate a permanently active interrupt signal which follows the status of the corresponding flags. When the interrupt sources are all disabled, INTA/B remains high-impedance.

- The flags MSF, AF, TSFx, and BF can be cleared by command.
- The flag WDTF is read only. How it can be cleared is explained in <u>Section 7.11.5</u>.
- The flag BLF is read only. It is cleared automatically from the battery low detection circuit when the battery is replaced.



When SI, MI, WD_CD, AIE, TSIE1/2/3/4, BIE, BLIE are all disabled, $\overline{\text{INTA}/\text{INTB}}$ remains high-impedance.

Figure 15. Interrupt block diagram

7.13.1 Minute and second interrupts

Minute and second interrupts are generated by predefined timers. The timers can be enabled independently from one another by the bits MI and SI in register Control_1. However, a minute interrupt enabled on top of a second interrupt cannot be distinguishable since it occurs at the same time.

The minute/second flag MSF (register Control_2) is set logic 1 when either the seconds or the minutes counter increments according to the enabled interrupt (see <u>Table 79</u>). The MSF flag can be cleared by command.

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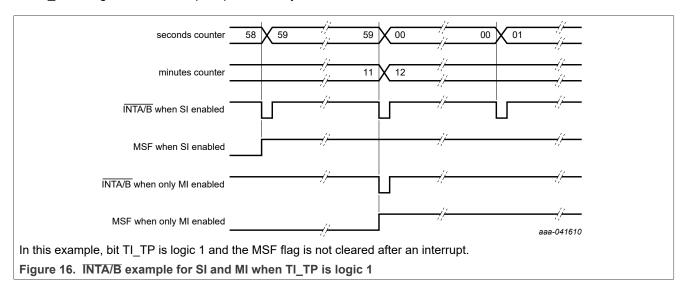
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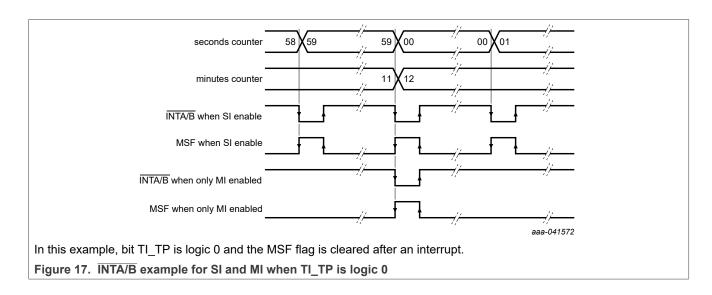
Table 79. Effect of bits MI and SI on pin INTA/B and bit MSF

MI	SI	Result in INTA/B	Result on MSF
0	0	No interrupt generated	MSF never sets
1	0	An interrupt once per minute	MSF is set when minutes counter increments
0	1	An interrupt once per second	MSF is set when seconds counter increments
1	1	An interrupt once per second	MSF is set when seconds counter increments

When MSF is set logic 1:

- If TI TP is logic 1, the interrupt is generated as a pulsed signal if not masked.
- If TI_TP is logic 0, the interrupt is permanently active until MSF is cleared.



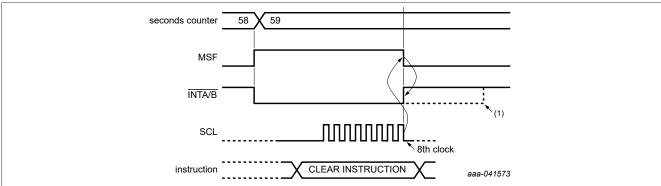


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The pulse generator for the minute/second interrupt operates from an internal 64 Hz clock and generates a pulse of $\frac{1}{64}$ seconds in duration.

7.13.2 INTA/B pulse shortening

If the MSF flag (register Control_2) is cleared before the end of the INTA/B pulse, then the INTA/B pulse is shortened. This allows the source of a system interrupt to be cleared immediately when it is serviced, that is, the system does not have to wait for the completion of the pulse before continuing; see <u>Figure 18</u>. Instructions for clearing the bit MSF can be found in <u>Section 7.11.5</u>.



1. Indicates normal duration of INTA/B pulse.

The timing shown for clearing bit MSF is also valid for the non-pulsed interrupt mode, that is, when TI_TP is logic 0, where the $\overline{INTA/B}$ pulse may be shortened by setting both bits MI and SI logic 0.

Figure 18. Example of shortening the INTA/B pulse by clearing the MSF flag

7.13.3 Watchdog timer interrupts

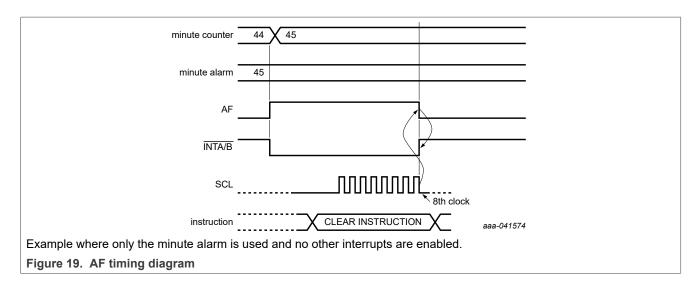
The generation of interrupts from the watchdog timer is controlled using the WD_CD bit (register Watchdg_tim_ctl). The interrupt is generated as an active signal which follows the status of the watchdog timer flag WDTF (register Control 2) if not masked. No pulse generation is possible for watchdog timer interrupts.

The interrupt is cleared when the flag WDTF is reset. Instructions for clearing it can be found in Section 7.11.5.

7.13.4 Alarm interrupts

Generation of interrupts from the alarm function is controlled by the bit AIE (register Control_2). If AIE is enabled, the INTA/B pin follows the status of bit AF (register Control_2) if not masked. Clearing AF immediately clears INTA/B. No pulse generation is possible for alarm interrupts.

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7.13.5 Timestamp interrupts

Interrupt generation from the timestamp function is controlled using the TSIE1-4 bit (register Control_5). If TSIE1-4 is enabled, the INTA/B pin follows the status of the flags TSF1/2/3/4, if not masked. Clearing the flags TSFx immediately clears INTA/B. No pulse generation is possible for timestamp interrupts.

7.13.6 Battery switch-over interrupts

Generation of interrupts from the battery switch-over is controlled by the BIE bit (register Control_3). If BIE is enabled, the INTA/B pin follows the status of bit BF in register Control_3 if not masked(see <u>Table 78</u>). Clearing BF immediately clears INTA/B. No pulse generation is possible for battery switch-over interrupts.

7.13.7 Battery low detection interrupts

Generation of interrupts from the battery low detection is controlled by the BLIE bit (register Control_3). If BLIE is enabled, the INTA/B pin follows the status of bit BLF (register Control_3) if not masked. The interrupt is cleared when the battery is replaced (BLF is logic 0) or when bit BLIE is disabled (BLIE is logic 0). BLF is read only and therefore cannot be cleared by command.

7.13.8 Interrupt masks

Table 80. INT_A/B_MASK1 - interrupt mask 1 register (address 31h/33h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0			
Symbol	INT_A/B_MA	NT_A/B_MASK1									
Reset value	-	-	1	1	1	1	1	1			

Table 81. INT_A/B_MASK1 - interrupt mask 1 register (address 31h/33h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
7 to 6	Т	00	Unused

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Table 81. INT_A/B_MASK1 - interrupt mask 1 register (address 31h/33h) bit description...continued Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
5	MIA/B	1	Minute interrupt mask
4	SIA/B	1	Second interrupt mask
3	WD_CDA/B	1	Watchdog interrupt mask
2	AIEA/B	1	Alarm interrupt mask
1	BIEA/B	1	Battery flag interrupt mask
0	BLIEA/B	1	Battery low flag interrupt mask

Table 82. INT_A/B_MASK2 - interrupt mask 2 register (address 32h/34h) bit allocation Bits labeled as T are unused and return 0 when read.

Bit	7	6	5	4	3	2	1	0				
Symbol	INT_A/B_MA	INT_A/B_MASK2										
Reset value	Т	Т	Т	Т	1	1	1	1				

Table 83. INT_A/B_MASK2 - interrupt mask 2 register (address 32h/34h) bit description Bits labeled as T are unused and return 0 when read.

Bit	Symbol	Value	Description
7 to 4	Т	0000	Unused
3	TSIE1A/B	1	Timestamp 1 interrupt mask
2	TSIE2A/B	1	Time stamp 2 interrupt mask
1	TSIE3A/B	1	Time stamp 3 interrupt mask
0	TSIE4A/B	1	Time stamp 4 interrupt mask

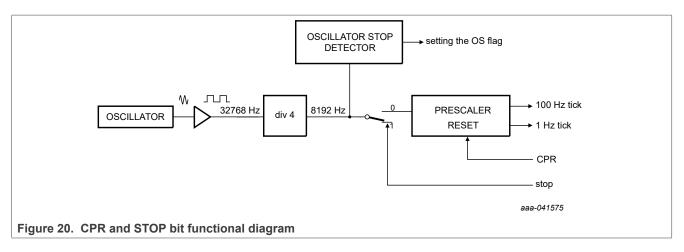
The registers at addresses 31h to 32h are used to configure interrupt source for $\overline{\text{INTA}}$ pin, and the registers at addresses 33h to 34h are for $\overline{\text{INTB}}$ pin.

All of above interrupts could be masked from either $\overline{\text{INTA}}$ or $\overline{\text{INTB}}$, with corresponding bit set to '1', as shown in Figure 15.

7.14 STOP bit function

The STOP bit stops the time from counting. STOP must be set to unlock the time and date registers to set the time.

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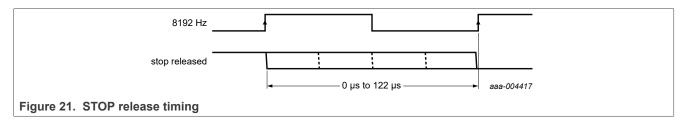


The *stop* signal blocks the 8.192 kHz clock from generating system clocks and freezes the time. In this state, the prescaler can be cleared with the CPR command in the Resets register.

Remark: The CLKOUT output of clock frequencies is not affected.

The time circuits can then be set and do not increment until the STOP bit is released. There is a slight chance that STOP is set during a carry over of multiple time registers, which may have been executed incomplete. Therefore, time must be set before clearing STOP to maintain time integrity.

The *stop* acts on the 8.192 kHz signal. Because the I²C-bus or TS pin input is asynchronous to the crystal oscillator, the accuracy of restarting the time circuits is between zero and one 8.192 kHz cycle (see <u>Figure 21</u>).



The first increment of the time circuits is between 0 s and 122 µs after STOP is released.

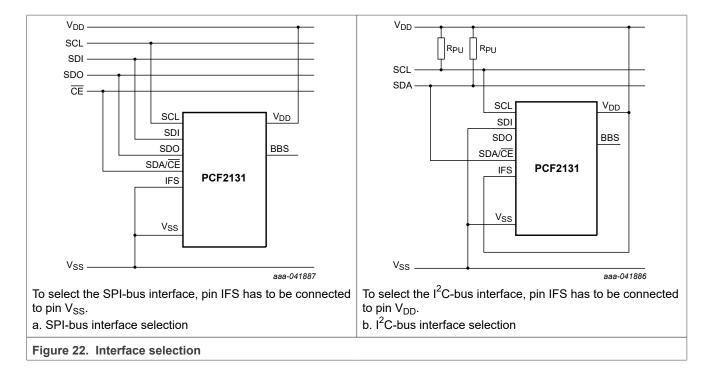
7.15 Interfaces

The PCF2131 has an I^2 C-bus or SPI-bus interface using the same pins. The selection is done using the interface selection pin IFS (see <u>Table 84</u>).

Table 84. Interface selection input pin IFS

Pin	Connection	Bus interface	Reference
IFS	V_{SS}	SPI-bus	<u>Section 7.15.1</u>
	V_{DD}	l ² C-bus	<u>Section 7.15.2</u>

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7.15.1 SPI-bus interface

Data transfer to and from the device is made by a 4-line SPI-bus (see $\underline{\text{Table 85}}$). The data lines for input and output are split. The SPI-bus is initialized whenever the chip enable line pin SDA/ $\overline{\text{CE}}$ is inactive.

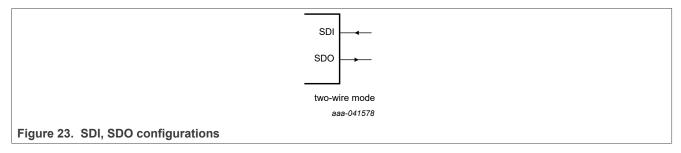


Table 85. Serial interface

Symbol	Function	Note	Description
SDA/CE	Chip enable input; active LOW	[1]	When HIGH, the interface is reset; Input may be higher than V _{DD}
SCL	Serial clock input		When SDA/CE is HIGH, input may float; Input may be higher than V _{DD}
SDI	Serial data input		When SDA/CE is HIGH, input may float; Input may be higher than V _{DD} ; Input data is sampled on the rising edge of SCL
SDO	Serial data output		Push-pull output; Drives from V _{SS} to V _{oper(int)} (V _{BBS}); Output data is changed on the falling edge of SCL

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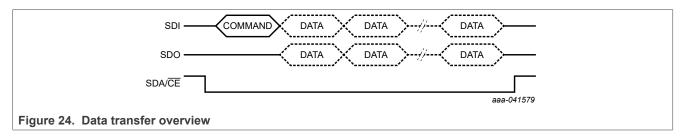
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[1] The chip enable must not be wired permanently LOW.

7.15.1.1 Data transmission

The chip enable signal is used to identify the transmitted data. Each data transfer is a whole byte, with the Most Significant Bit (MSB) sent first.

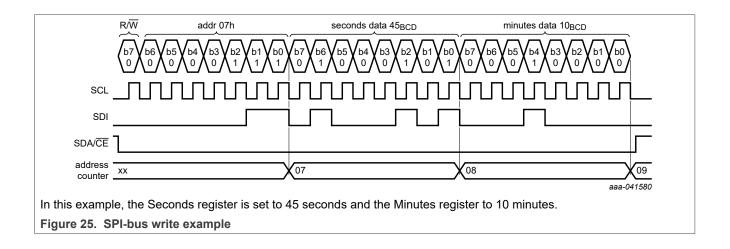
The transmission is controlled by the active LOW chip enable signal SDA/CE. The first byte transmitted is the command byte. Subsequent bytes are either data to be written or data to be read (see Figure 24).



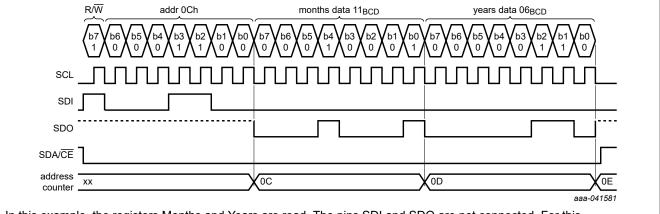
The command byte defines the address of the first register to be accessed and the read/write mode. The address counter will auto increment after every access and will reset to zero after the last valid register is accessed. The R/W bit defines if the following bytes are read or write information.

Table 86. Command byte definition

Bit	Symbol	Value	Description
7	R/W		Data read or write selection
		0	Write data
		1	Read data
6 to 0	RA	00h to 36h	Register address



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In this example, the registers Months and Years are read. The pins SDI and SDO are not connected. For this configuration, it is important that pin SDI is never left floating. It must always be driven either HIGH or LOW. If pin SDI is left open, high I_{DD} currents may result.

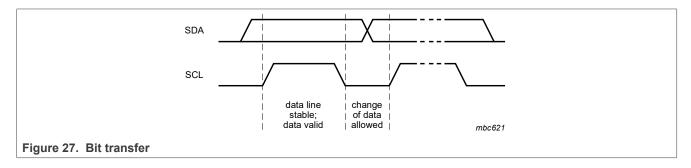
Figure 26. SPI-bus read example

7.15.2 I²C-bus interface

The I²C-bus is for bidirectional, two-line communication between different ICs or modules. The two lines are a Serial Data Line (SDA) and a Serial Clock Line (SCL). Both lines are connected to a positive supply by a pull-up resistor. Data transfer is initiated only when the bus is not busy.

7.15.2.1 Bit transfer

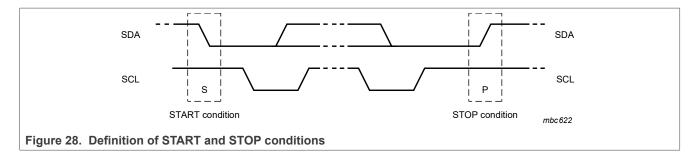
One data bit is transferred during each clock pulse. The data on the SDA line remains stable during the HIGH period of the clock pulse as changes in the data line at this time are interpreted as control signals (see Figure 27).



7.15.2.2 START and STOP conditions

Both data and clock lines remain HIGH when the bus is not busy. A HIGH-to-LOW transition of the data line, while the clock is HIGH, is defined as the START condition S. A LOW-to-HIGH transition of the data line while the clock is HIGH is defined as the STOP condition P (see <u>Figure 28</u>).

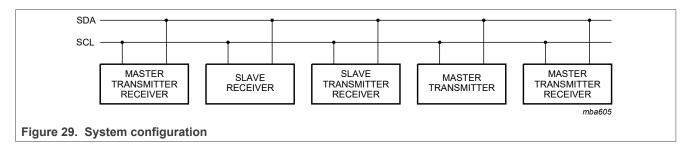
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7.15.2.3 System configuration

A device generating a message is a transmitter; a device receiving a message is the receiver. The device that controls the message is the master; and the devices which are controlled by the master are the slaves.

The PCF2131 can act as a slave transmitter and a slave receiver.



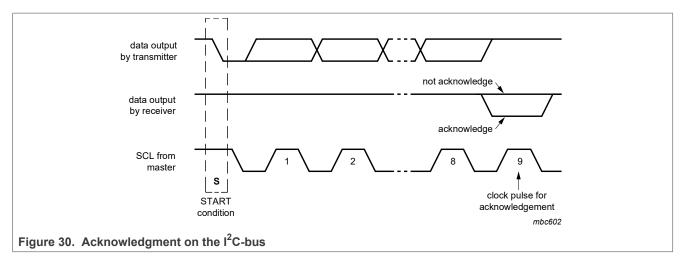
7.15.2.4 Acknowledge

The number of data bytes transferred between the START and STOP conditions from transmitter to receiver is unlimited. Each byte of 8 bits is followed by an acknowledge cycle.

- A slave receiver which is addressed must generate an acknowledge after the reception of each byte.
- Also, a master receiver must generate an acknowledge after the reception of each byte that has been clocked out of the slave transmitter.
- The device that acknowledges must pull-down the SDA line during the acknowledge clock pulse, so that the SDA line is stable LOW during the HIGH period of the acknowledge related clock pulse (set-up and hold times must be considered).
- A master receiver must signal an end of data to the transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this event, the transmitter must leave the data line HIGH to enable the master to generate a STOP condition.

Acknowledgment on the I²C-bus is illustrated in Figure 30.

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7.15.2.5 I²C-bus protocol

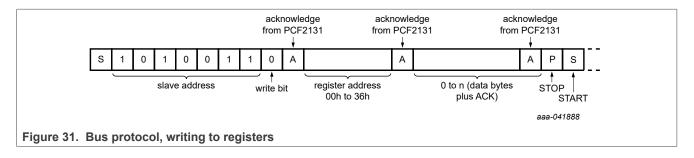
After a start condition, a valid hardware address has to be sent to a PCF2131 device. The appropriate I²C-bus slave address is 1010 011. The entire I²C-bus slave address byte is shown in Table 87.

Table 87. I²C slave address byte

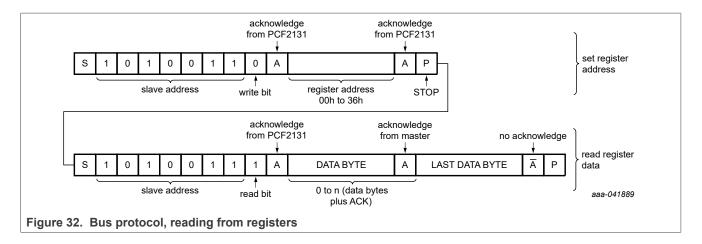
		,						
	Slave address							
Bit	7	6	5	4	3	2	1	0
	MSB							LSB
	1	0	1	0	0	1	1	R/W

The R/W bit defines the direction of the following single or multiple byte data transfer (read is logic 1, write is logic 0).

For the format and the timing of the START condition (S), the STOP condition (P), and the acknowledge (A) refer to the I²C-bus specification <u>ref.[3]</u> and the characteristics table (<u>Table 92</u>). In the write mode, a data transfer is terminated by sending a STOP condition.



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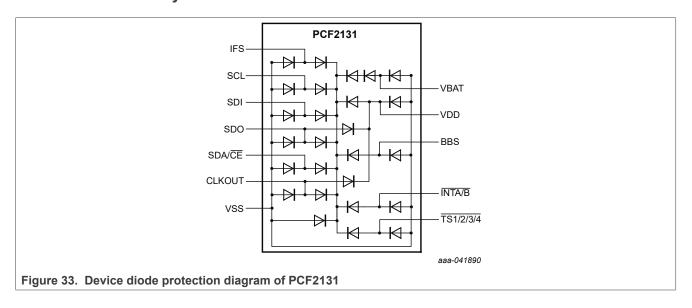
7.15.3 Bus communication and battery backup operation

To save power during battery backup operation (see Section 7.5.1), the bus interfaces are inactive. Therefore, the communication via I^2C - or SPI-bus should be terminated before the supply of the PCF2131 is switched from V_{DD} to V_{BAT} .

With I2C interface, PCF2131 terminates transaction before switching from V_{DD} to V_{BAT} , with SPI interface, PCF2131 corrupts SPI write and read data when battery switchover occurs.

Remark: If the I²C-bus communication was terminated uncontrollably, the I²C-bus has to be reinitialized by sending a STOP followed by a START after the device switched back from battery backup operation to V_{DD} supply operation.

7.16 Internal circuitry



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7.17 Safety notes

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

Limiting values

Table 88. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Note	Min	Max	Unit
V _{DD}	Supply voltage			-0.5	+6.5	V
I _{DD}	Supply current			-50	+50	mA
Vi	Input voltage			-0.5	+6.5	V
I _I	Input current			-10	+10	mA
Vo	Output voltage			-0.5	+6.5	V
Io	Output current			-10	+10	mA
		At pin SDA/CE		-10	+20	mA
V _{BAT}	Battery supply voltage			-0.5	+6.5	V
P _{tot}	Total power dissipation			-	300	mW
V _{ESD}	Electrostatic discharge	HBM	[1]	-	±2 000	V
	voltage	CDM	[2]	-	±500	V
I _{lu}	Latch-up current		[3]	-	1 00	mA
T _{stg}	Storage temperature		[4]	-55	+85	°C
T _{amb}	Ambient temperature	Operating device		-40	+85	°C

Pass level; Human Body Model (HBM) according to AEC Q100-002.

Note: The PCF2131 part is not guaranteed (nor characterized) above the operating range as denoted in the data sheet. NXP recommends not to bias the PCF2131 device during reflow (for example, if using a 'coin' type battery in the assembly). If the customer so chooses to use this assembly method, there must be the allowance for a full \Q0 V' level power supply \Qreset' to re-enable the device. Without a proper POR, the device may remain in an indeterminate state.

Pass level (750 V for corner pins); Charged-Device Model (CDM), according to AEC Q100-011.

Pass level; latch-up testing according to AEC Q100-004 at maximum ambient temperature (T_{amb(max)}).

According to the store and transport requirements (see ref.[4]) the devices have to be stored at a temperature of +8 °C to +45 °C and a humidity of 25 % to 75 %.

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9 Static characteristics

Table 89. Static characteristics

 V_{DD} = 1.2 V to 5.5 V; V_{SS} = 0 V; T_{amb} = -40 °C to +85 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Note	Min	Тур	Max	Unit			
Supplies										
V _{DD}	Supply voltage		[1]	1.2	-	5.5	V			
/ _{BAT}	Battery supply voltage			1.2	-	5.5	V			
/ _{low}	Low voltage			-	1.15	-	V			
OD		Interface active; supplied by V _{DD}								
Supply cur	rent ^[2]	SPI-bus (f _{SCL} = 6.5 MHz)		-	-	800	μA			
		I^2 C-bus (f _{SCL} = 400 kHz)		-	-	200	μA			
		Interface inactive (f _{SCL} = 0 Hz)	^[3] ; TCI	R[1:0] = 00 (:	see <u>Table 16</u>)				
		COF[2:0] = 111 (see <u>Table 1</u>	PWRMNG[2:0] = 111 (see <u>Table 22</u>); COF[2:0] = 111 (see <u>Table 18</u>) TC_DIS = 1 (see <u>Table 5</u>); 100TH_S_DIS = 1 (see <u>Table 5</u>)							
		V _{DD} = 1.2 V		-	88	400	nA			
		V _{DD} = 3.3 V		-	64	350 ^[4]	nA			
		V _{DD} = 5.5 V		-	71	450	nA			
		PWRMNG[2:0] = 111 (see <u>Table 22</u>); COF[2:0] = 111 (see <u>Table 18</u>) TC_DIS = 0 (see <u>Table 5</u>); 100TH_S_DIS = 1 (see <u>Table 5</u>)								
		V _{DD} = 1.2 V		-	101	500	nA			
		V _{DD} = 3.3 V		-	70	450	nA			
		V _{DD} = 5.5 V		-	76	550	nA			
		COF[2:0] = 000 (see <u>Table</u>	PWRMNG[2:0] = 111 (see <u>Table 22</u>); COF[2:0] = 000 (see <u>Table 18</u>) TC_DIS = 0 (see <u>Table 5</u>); 100TH_S_DIS = 0 (see <u>Table 5</u>);							
		V _{DD} = 1.2 V	[5]	-	460	770	nA			
		V _{DD} = 3.3 V	[5]	-	1035	1365	nA			
		V _{DD} = 5.5 V	[5]	-	1670	2135	nA			
		PWRMNG[2:0] = 000 (see	<u>18</u>)	,	see <u>Table 5</u>)					
		V _{DD} = 1.8 V, V _{BAT} = 1.5 V		-	118	500	nA			
		V _{DD} = 3.3 V, V _{BAT} = 3.3 V		-	104	500	nA			
		V _{DD} = 5.5 V, V _{BAT} = 3.3 V		-	107	550	nA			
		V _{BAT} = 1.2 V, I _{BAT}	[6]	-	104	565	nA			
		V _{BAT} = 3.3 V, I _{BAT} :	[6]	-	83	450	nA			
		V _{BAT} = 5.5 V, I _{BAT} :	[6]	-	91	625	nA			
		PWRMNG[2:0] = 000 (see			1	+				

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Document feedback

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Table 89. Static characteristics...continued

 V_{DD} = 1.2 V to 5.5 V; V_{SS} = 0 V; T_{amb} = -40 °C to +85 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Note	Min	Тур	Max	Unit
Supply cur	rent [2]	COF[2:0] = 000 (see <u>Table 1</u> TC_DIS = 0 (see <u>Table 5</u>); 1	,	S_DIS = 0	(see <u>Table 5</u>)		
		V _{DD} = 1.8 V, V _{BAT} = 1.5 V	[5]	-	640	945	nA
		V _{DD} = 3.3 V, V _{BAT} = 3.3 V	[5]	-	1060	1410	nA
		V _{DD} = 5.5 V, V _{BAT} = 3.3 V	[5]	-	1705	2190	nA
		V _{BAT} = 1.2 V, I _{BAT}	[6]	-	130	390	nA
		V _{BAT} = 3.3 V, I _{BAT}	[6]	-	145	390	nA
		V _{BAT} = 5.5 V, I _{BAT}	[6]	-	210	500	nA
I _{L(bat)}	Battery leakage current	V _{DD} is active supply; V _{BAT} = 3.0 V		-	0.1	-	nA
Power ma	nagement		1				1
V _{th(sw)bat}	Battery switch threshold voltage			2.3	2.5		V
V _{th(bat)low}	Low battery threshold voltage			2.3	2.5		V
Inputs ^[7]			1		1	1	
Vı	Input voltage			-0.5	-	V _{DD} + 0.5	V
V _{IL}	LOW-level input voltage			-	-	0.25V _{DD}	V
		T _{amb} = -40 °C to +85 °C; V _{DD} > 2.0 V		-	-	0.3V _{DD}	V
V _{IH}	HIGH-level input voltage			0.7V _{DD}	-	-	V
I _{LI}	Input leakage current	V _I = V _{DD} or V _{SS}		-	0	-	μA
		Post ESD event		-1	-	+1	μA
C _i	Input capacitance		[8]	-	-	7	pF
Outputs			1				
V _O	Output voltage	On pins INTA/B, referring to external pull-up		-0.5	-	5.5	V
		On pin BBS	[9]	1.2	-	5.5	V
V _{OH}	HIGH output voltage	On pin SDO, CLKOUT at 1 mA source current		0.8V _{DD}	-	V_{DD}	V
V _{OL}	LOW output voltage	On pins CLKOUT, INTA/B and SDO at 1 mA sink current		V _{SS}	-	0.2V _{DD}	V
		On pin SDA, V _{DD} > 2.0 V, 3 mA sink current		-	-	0.4	V
		On pin SDA, V _{DD} < 2.0 V, 2 mA sink current		-	-	0.2V _{DD}	V
I _{OL}	LOW-level output current	Output sink current; V _{OL} = 0.4 V	•		•		•

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Table 89. Static characteristics...continued

 V_{DD} = 1.2 V to 5.5 V; V_{SS} = 0 V; T_{amb} = -40 °C to +85 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Note	Min	Тур	Max	Unit
		On pin SDA/CE	[10]	3	-	-	mA
		On all other outputs		1.0	-	-	mA
Гон	HIGH-level output current	Output source current; on pin SDO, CLKOUT; $V_{OH} = 0.8 * V_{DD}$		1.0	-	-	mA
I _{LO}	output leakage current	$V_O = V_{DD}$ or V_{SS}		-	0	-	μA
		Post ESD event		-1	-	+1	μA

- For reliable oscillator start-up and OTP refresh at power on: V_{DD} needs to be above 1.8 V. [1]
- MAX I_{DD} and I_{BAT} determined by characterization.
- Timer source clock = $\frac{1}{60}$ Hz, level of pins SDA/ \overline{CE} , SDI, and SCL is V_{DD} or V_{SS} .
- [4] Production tested I_{DD}parameter.
- [5] Any load in the application driven by CLKOUT adds to this value, for example, 10 pF, Vdd = 3v3 will add 32768 Hz * 10 pF * 3.3 V = 1.1 μA.
- [6] When the device is supplied by the V_{BAT} pin instead of the V_{DD} pin, V_{DD} = 0 V. The device can only start up from V_{DD} .
- [7] The I²C-bus and SPI-bus interfaces of PCF2131 are 5 V tolerant.
- Tested on a sample basis.
- Pin BBS is internally connected to either V_{DD} or V_{BAT} , see section Section 7.5.3.
- [10] For further information, see Figure 34.

9.1 Current consumption characteristics, typical

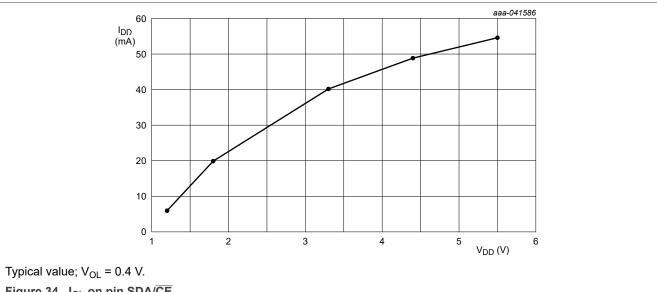
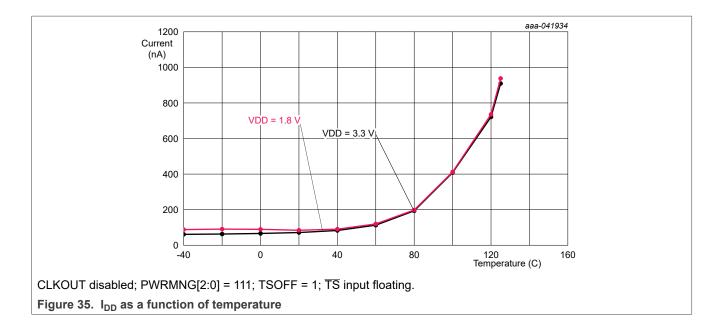
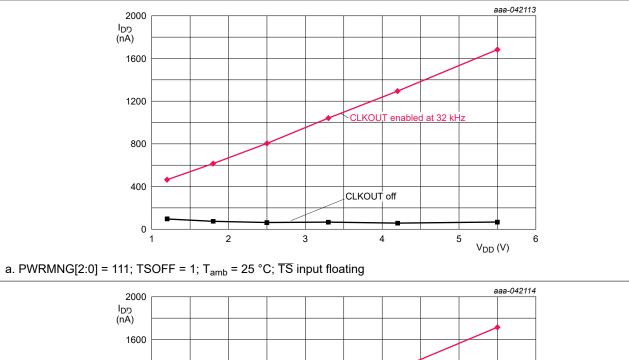


Figure 34. I_{OL} on pin SDA/CE

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b. PWRMNG[2:0] = 000; TSOFF = 0; T_{amb} = 25 °C; \overline{TS} input floating

Figure 36. I_{DD} as a function of V_{DD}

9.2 Frequency characteristics

Table 90. Frequency characteristics

 V_{DD} = 1.2 V to 5.5 V; V_{SS} = 0 V; T_{amb} = +25 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
f _o	Output frequency	On pin CLKOUT; V _{DD} = 3.3 V; COF[2:0] = 000; AO[3:0] = 1000		-	32.768	-	kHz
Δf/f	Time accuracy	V_{DD} or V_{BAT} = 3.3 V, Tamb = -40 °C to +85 °C					
		TC_DIS = 0	[1] [2]	_	±3	+8	ppm
		TC_DIS = 1	[1] [2]	-200		+4	ppm

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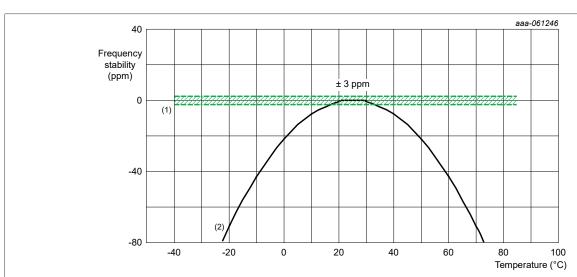
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Table 90. Frequency characteristics...continued

 V_{DD} = 1.2 V to 5.5 V; V_{SS} = 0 V; T_{amb} = +25 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
		TC_DIS = 1, Tamb = 25 °C	[1] [2]	-3		+3	ppm
Δf _{xtal} /f _{xtal} Relative crystal frequency variation	1	Crystal aging					
	PCF2131						
		First year; V _{DD} or V _{BAT} = 3.3 V	[3]	-3	-	+3	ppm
Δf/ΔV	Frequency variation with the voltage	On pin CLKOUT		-	±1	-	ppm/V
Jitter	Output clock peak-to- peak jitter	On pin CLKOUT		-	50	-	ns

- ± 1 ppm corresponds to a time deviation of ± 0.0864 seconds per day. Only valid if CLKOUT frequencies are not equal to 32.768 kHz or if CLKOUT is disabled.
- Not production tested. Effects of reflow soldering are included (see application note AN13203).



- 1. Performance is achieved with temperature compensation.
- 2. Typical uncalibrated oscillator performance.

Figure 37. Temperature compensation comparison

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10 Dynamic characteristics

This section explains about the SPI-bus timing characteristics and I²C-bus timing characteristics.

10.1 SPI-bus timing characteristics

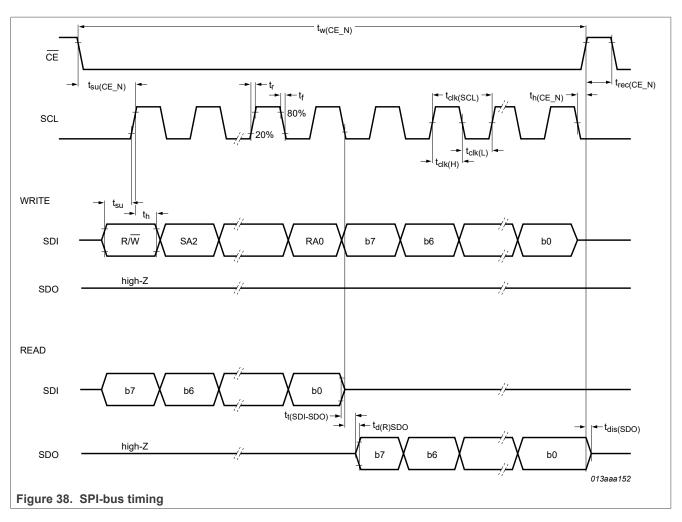
Table 91. SPI-bus characteristics

 V_{DD} = 1.2 V to 5.5 V; V_{SS} = 0 V; T_{amb} = -40 °C to +105 °C, unless otherwise specified. All timing values are valid within the operating supply voltage at ambient temperature and referenced to V_{IL} and V_{IH} with an input voltage swing of V_{SS} to V_{DD} (see <u>Figure 38</u>).

Symbol	Parameter	Conditions	Note	V _{DD} = 1.2	V _{DD} = 1.2 V to 3.3 V		V _{DD} = 3.3 V to 5.5 V	
				Min	Max	Min	Max	
Pin SCL								
f _{clk(SCL)}	SCL clock frequency			-	0.5	-	6.5	MHz
t _{clk(H)}	Clock HIGH time			1000	-	70	-	ns
t _{clk(L)}	Clock LOW time			1000	-	70	-	ns
t _r	Rise time	For SCL signal		-	100	-	100	ns
t _f	Fall time	For SCL signal		-	100	-	100	ns
Pin SDA/	Œ		-					
t _{su(CE_N)}	CE_N set-up time			300	-	30	-	ns
t _{h(CE_N)}	CE_N hold time			325	-	25	-	ns
t _{rec(CE_N)}	CE_N recovery time			1500	-	1500	-	ns
t _{w(CE_N)}	CE_N pulse width			-	0.99	-	0.99	s
Pin SDI			•		,			
t _{su}	Set-up time	Set-up time for SDI data		250	-	20	-	ns
t _h	Hold time	Hold time for SDI data		250	-	20	-	ns
Pin SDO			-1	'	<u> </u>	-		
t _{d(R)SDO}	SDO read delay time	C _L = 50 pF		-	550	-	55	ns
t _{dis(SDO)}	SDO disable time		[1] -	150	-	25	ns

^[1] No load value; bus is held up by bus capacitance; use RC time constant with application values.

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10.2 I²C-bus timing characteristics

Table 92. I²C-bus characteristics

All timing characteristics are valid within the operating supply voltage and ambient temperature range and reference to 30 % and 70 % with an input voltage swing of V_{SS} to V_{DD} (see <u>Figure 39</u>).

Symbol	Parameter		Standard mode		Fast-mod	Fast-mode (Fm)	
			Min	Max	Min	Max	
Pin SCL						<u> </u>	
f _{SCL}	SCL clock frequency	[1]	10	100	10	400	kHz
t _{LOW}	LOW period of the SCL clock		4.7	-	1.3	-	μs
t _{HIGH}	HIGH period of the SCL clock		4.0	-	0.6	-	μs
Pin SDA/	CE	,		,		-	·
t _{SU;DAT}	Data set-up time		250	-	100	-	ns
t _{HD;DAT}	Data hold time	[2] [2]	0	-	0	-	ns
Pins SCL	and SDA/CE		l				

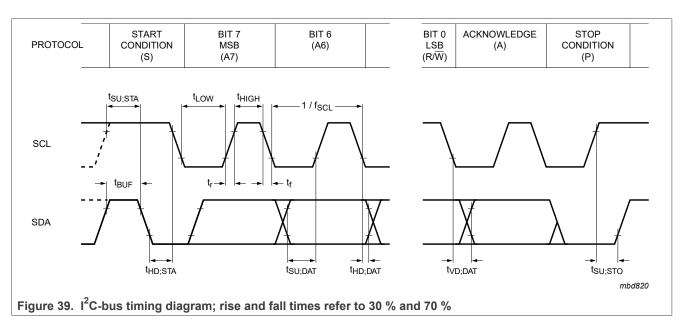
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Table 92. I²C-bus characteristics...continued

All timing characteristics are valid within the operating supply voltage and ambient temperature range and reference to 30 % and 70 % with an input voltage swing of V_{SS} to V_{DD} (see <u>Figure 39</u>).

Symbol	Parameter		Standard	d mode	Fast-mode (Fast-mode (Fm)	
		Min	Max	Min	Max		
t _{BUF}	Bus free time between a STOP and START condition		4.7	-	1.5	-	μs
t _{SU;STO}	Set-up time for STOP condition		4.0	-	0.6	-	μs
t _{HD;STA}	Hold time (repeated) START condition		4.0	-	0.6	-	μs
t _{SU;STA}	Set-up time for a repeated START condition		4.7	-	0.6	-	μs
t _r	Rise time of both SDA and SCL signals	[2] [3] [4]	-	1 000	20 + 0.1C _b	300	ns
t _f	Fall time of both SDA and SCL signals	[2] [3] [4]	-	300	20 + 0.1C _b	300	ns
t _{VD;ACK}	Data valid acknowledge time	[5]	-	3.45	-	0.9	μs
t _{VD;DAT}	Data valid time	[6]	-	3.45	-	0.9	μs
t _{SP}	Pulse width of spikes that must be suppressed by the input filter	[7]	-	50	-	50	ns

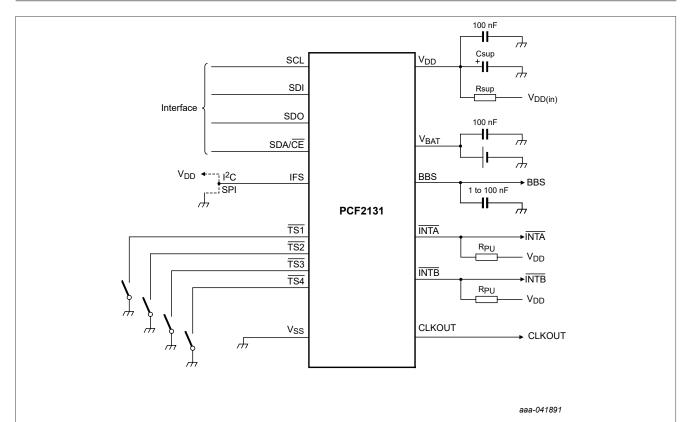
- [1] The minimum SCL clock frequency is limited by the bus time-out feature which resets the serial bus interface if either the SDA or SCL is held LOW for a minimum of 25 ms. The bus time-out feature must be disabled for DC operation.
- [2] A master device must internally provide a hold time of at least 300 ns for the SDA signal (refer to the V_{IL} of the SCL signal) in order to bridge the undefined region of the falling edge of SCL.
- [3] C_b is the total capacitance of one bus line in pF.
- [4] The maximum t_f for the SDA and SCL bus lines is 300 ns. The maximum fall time for the SDA output stage, t_f is 250 ns. This allows series protection resistors to be connected between the SDA/CE pin, the SCL pin, and the SDA/SCL bus lines without exceeding the maximum t_f.
- [5] $t_{VD;ACK}$ is the time of the acknowledgment signal from SCL LOW to SDA (out) LOW.
- [6] t_{VD:DAT} is the minimum time for valid SDA (out) data following SCL LOW.
- [7] Input filters on the SDA and SCL inputs suppress noise spikes of less than 50 ns.



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11 Application information



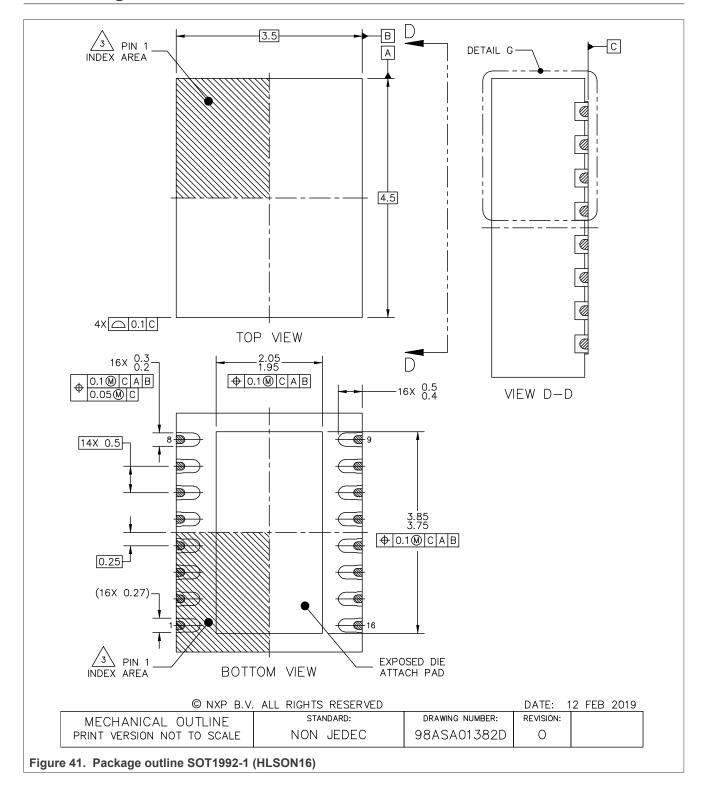
 R_{PU} : 10 k Ω is recommended.

 R_{SUP} and C_{SUP} : An appropriate RC filter needs to be added to guarantee the chip only sees <0.35 V/ms ramp down rate on supply, even if Vdd_in ramp rate is high.

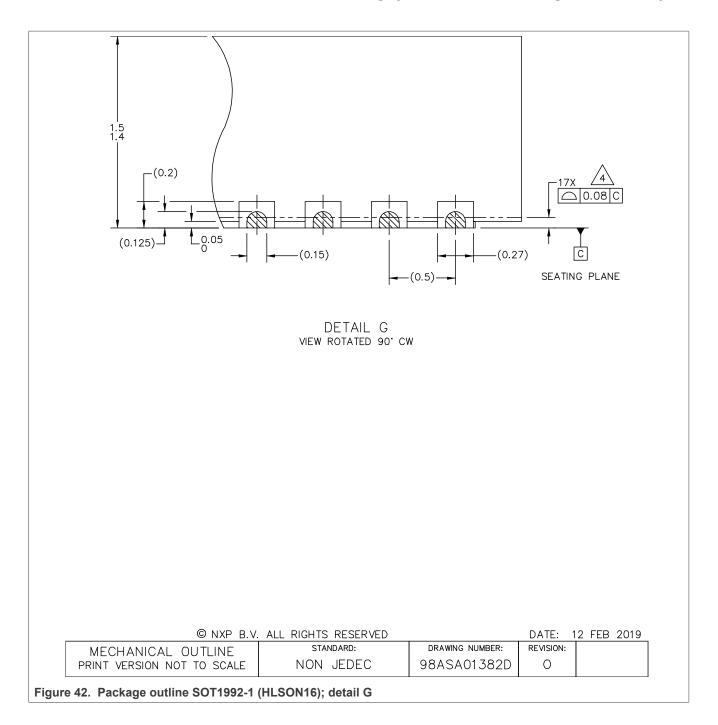
Figure 40. General application diagram

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12 Package outline



Nano-Power Highly Accurate RTC with Integrated Quartz Crystal



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NOTES:

- 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

3. PIN 1 FEATURE SHAPE, SIZE AND LOCATION MAY VARY.

4. COPLANARITY APPLIES TO LEADS.

5. MIN. METAL GAP SHOULD BE 0.2 MM.

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Figure 43. Package outline SOT1992-1 (HLSON16); notes

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13 Packing information

13.1 Tape and reel information

For tape and reel packing information, see ref.[2].

14 Soldering

For information about soldering, see ref.[1].

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14.1 Footprint information

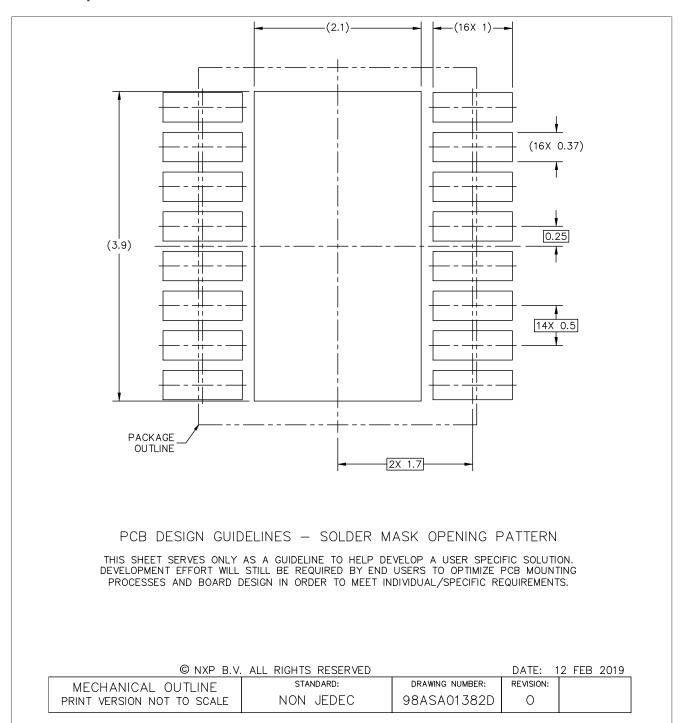


Figure 44. Footprint information part 1 for reflow soldering of SOT1992-1 (HLSON16)

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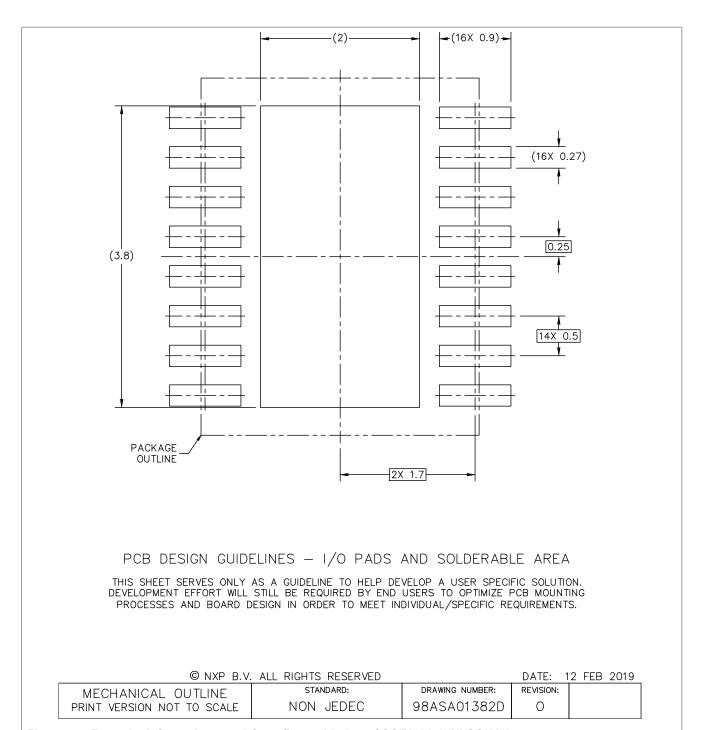
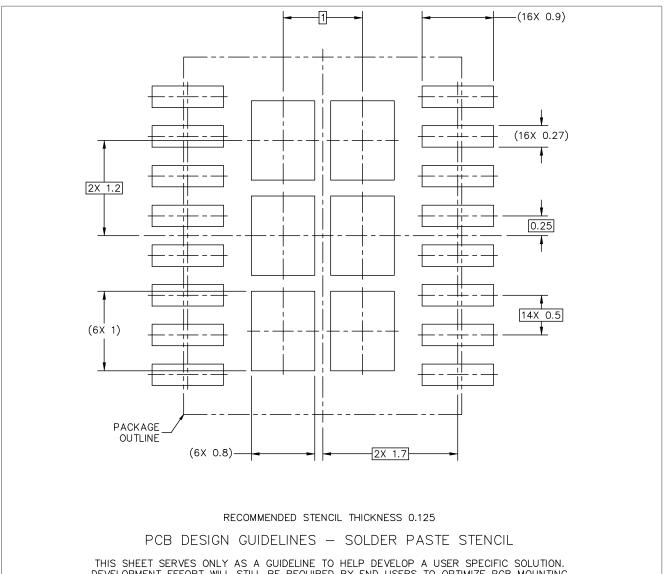


Figure 45. Footprint information part 2 for reflow soldering of SOT1992-1 (HLSON16)

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Figure 46. Footprint information part 3 for reflow soldering of SOT1992-1 (HLSON16)

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15 Appendix

15.1 RTC selection

Table 93. Selection of RTCs

Type name	Alarm, Timer, Watchdog	Interrupt output	Interface	I _{DD} typical (nA)	Battery backup	Timestamp, tamper input	AEC-Q100 compliant	Special features	Packages
PCF8563	X	1	I ² C	250	-	-	-	-	SO8, TSSOP8, HVSON10
PCF8564A	Х	1	I ² C	250	-	-	-	Integrated oscillator caps	WLCSP
PCA8565	Х	1	I ² C	600	-	-	Segment B, grade 1	High robustness, T _{amb} = -40 °C to 125 °C	TSSOP8, HVSON10
PCA8565A	Х	1	I ² C	600	-	-	-	Integrated oscillator caps, T _{amb} = -40 °C to 125 °C	WLCSP
PCF85063	-	1	I ² C	220	-	-	-	Basic functions only, no alarm	HXSON8
PCF85063A	Х	1	I ² C	220	-	-	-	Tiny package	SO8, DFN2626-10, TSSOP8
PCF85063B	Х	1	SPI	220	-	-	-	Tiny package	DFN2626-10
PCA85073A	Х	1	I ² C	220	-	-	Segment B, grade 2	Tiny package	TSSOP8
PCF85263A	Х	2	I ² C	230	Х	1	-	Timestamp, battery backup, stopwatch $\frac{1}{100}$ s	SO8, TSSOP10, WLCSP12, TSSOP8, DFN2626-10
PCF85363A	Х	2	I ² C	230	Х	1	-	Timestamp, battery backup, stopwatch $\frac{1}{100}$ s, 64 Byte RAM	TSSOP10, DFN2626-10, TSSOP8
PCF8523	Х	2	I ² C	150	х	-	-	Lowest power 150 nA in operation, FM+ 1 MHz	SO8, HVSON8, TSSOP14, WLCSP
PCF2123	Х	1	SPI	100	-	-	-	Lowest power 100 nA in operation	TSSOP14, HVQFN16, WLCSP12
PCA21125	Х	1	SPI	820	-	-	Segment B, grade 1	High robustness, T _{amb} = -40 °C to 125 °C	TSSOP14
PCF2131	Х	2	I ² C and SPI	60	x	4	-	Temperature compensated, quartz built in, calibrated	HLSON16 with wettable flanks
PCA2131	Х	2	I ² C and SPI	106	Х	4	Segment B, grade 2	Temperature compensated, quartz built in, calibrated T _{amb} = -40 °C to 105 °C	HLSON16 with wettable flanks

16 Acronyms

Table 94. Acronyms

Acronym	Description
AM	Ante Meridiem
BCD	Binary Coded Decimal
CDM	Charged Device Model
CMOS	Complementary Metal-Oxide Semiconductor
DC	Direct Current
GPS	Global Positioning System
НВМ	Human Body Model
I ² C	Inter-Integrated Circuit
IC	Integrated Circuit
LSB	Least Significant Bit
MCU	Microcontroller Unit

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Table 94. Acronyms...continued

Acronym	Description
MM	Machine Model
MSB	Most Significant Bit
РМ	Post Meridiem
POR	Power-On Reset
PPM	Parts Per Million
RC	Resistance-Capacitance
RTC	Real-Time Clock
SCL	Serial Clock Line
SDA	Serial Data Line
SPI	Serial Peripheral Interface
SRAM	Static Random Access Memory
TCXO	Temperature Compensated Xtal Oscillator
Xtal	Crystal
AEC	Automotive Electronics Council
SDO	Serial Data Output
CE	Chip Enable
SR	Software Reset
CTS	Clear Timestamp
COF	CLKOUT Frequency
OTP	One Time Programmable
EPROM	Erasable Programmable Read-Only Memory

17 References

- [1] AN13203 Application and soldering information for the PCF2131 and PCA2131 RTC
- [2] SOT1992-1_518 HLSON16; Reel pack; SMD, 13", packing information
- [3] UM10204 I²C-bus specification and user manual
- [4] UM10569 Store and transport requirements

18 Revision history

Table 95. Revision history

Document ID	Release date	Description
PCF2131 v.2.2	20 June 2025	Updated the following sections as per CIN# 202506018I: Section 2 "Features and benefits" Section 7.2.1 Table 8 "Control_2 - control and status register 2 (address 01h) bit description" Section 7.7 "Power-On Reset function " Section 7.8.1 "SR: software reset"

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Table 95. Revision history...continued

Document ID	Release date	Description
		 Section 7.14 "STOP bit function" Section 10.2 "I2C-bus timing characteristics" Section 16 "Acronyms" Deleted the following sections: Power-On Reset Override (PORO) External clock test mode Updated the following figure: Figure 37 "Temperature compensation comparison" Made some editorial changes
PCF2131 v.2.1	27 January 2025	Updated per CIN 202411003I: • <u>Table 3</u> : Updated exposed pad recommendation
PCF2131 v.2.0	5 October 2023	 Table 4: 05h - corrected values for bits 6 to 1 Table 25: Corrected duplicate header bit 6 to bit 7 Table 92: t_{VD;DAT} unit corrected to µs Table 93: PCF2127 and PCA/F2129 are NRND and removed from selection table; PCA2131 corrected to Grade 2 which is 105 °C
PCF2131 v.1.1	15 October 2021	Product data sheet
PCF2131 v.1.0	28 May 2021	Product data sheet

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Legal information

Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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